PY32F072 Datasheet

32-bit ARM® Cortex®-M0+ Microcontroller

Puya Semiconductor (Shanghai) Co., Ltd

PY32F072 Series

ARM® 32-bit Cortex®-M0+ Microcontroller

Features

- Core
  - ARM® 32-bit Cortex®-M0+ CPU
  - Up to 72 MHz operating frequency
- Memories
  - Maximum 128K/ 96K/ 64K/ 32K bytes Flash memory
  - Maximum 16K/ 12K/ 8K/ 4K bytes SRAM
  - Clock management
  - External 4 to 32 MHz high speed crystal oscillator (HSE)
  - External 32.768 kHz low-speed crystal oscillator (LSE)
  - Internal 4/8/16/22.12/24 MHz high speed clock (HSI)
  - Internal 32.768 kHz low speed clock (LSI)
  - PLL (supports 2/3 multiplication of HSI or HSE)
- Power management and reset
  - Operating voltage: 1.7 V to 5.5 V
  - Low power modes : Sleep and Stop
  - Power-on/power- down reset (POR/PDR)
  - Brown-out reset (BOR)
  - Programmable voltage detection (PVD)
- General-purpose input and output (I/O)
  - Up to 58 I/Os, all available as external interrupts
  - Drive current 8 mA
- 7-channel DMA controller
- One 12-bit ADC
  - Up to 16 external input channels
  - Input voltage conversion range: 0 to V_{CCA}
- One 12-bit DAC, supports 2 channels
- 3 analog comparators

- 3-channel operational amplifier
- Support 8 * 36 / 4 * 40 LCD
- 13 timers
  - One 16-bit advanced-control timer (TIM1)
  - One 32-bit general-purpose timer (TIM2)
  - Five 16-bit general-purpose timers (TIM3/14/15/16/17)
  - Two basic timers (TIM6/TIM7)
  - A low power timer (LPTIM)
  - A independent watchdog timer (IWDT)
  - A window watchdog timer (WWDT)
  - A SysTick timer
- RTC
- Communication interfaces
  - Two serial peripheral interfaces (SPI) with I²S function
  - Four universal synchronous/asynchronous Transceivers (USARTs) , support automatic baud rate detection, two of USARTs support ISO7816, LIN and IrDA
  - Two I²C interfaces supporting standard mode (100 KHz), Fast mode (400 KHz), 7-bit/10-bit addressing mode and SMBus
  - USB 2.0 full-speed interface
  - CAN 2.0 standard communication interface
- Hardware CRC-32 module
- Hardware 32-bit divider
- Unique UID
- Serial wire debug (SWD)
- Operating temperature: -40 to 85℃
- Package: LQFP64, LQFP48, QFN64, QFN48,QFN32

Content

1. Introduction

PY32F072 series microcontrollers incorporate high-performance ARM® 32-bit Cortex®-M0+ core, wide operating range voltage, embedded memories with up to 128 Kbytes flash and 32 Kbytes SRAM, frequency up to 72 MHz, and contains various products in different package types. The chip integrates multi-channel I2C, SPI, USART and other communication peripherals, one 12-bit ADC, two DAC, 13 timers, one USB 2.0, one CAN 2.0, three comparators, three operational amplifiers, and one LCD driver.

PY32F072 series microcontrollers 's operate in the temperature range from -40 to 85°C and with operating voltages from 1.7 V to 5.5 V. The chip provides sleep and stop low-power operating modes, which can meet different low-power applications.

The devices are suitable for various application scenarios, such as controllers, portable devices, PC peripherals, gaming and GPS platforms, industrial applications.

Table 1- 1 PY32F072 series device features and peripheral counts

Peripheral		PY32F072Rx(64pin)	PY32F072Cx(48pin)	PY32F072Kx(32pin)
Flash memory (Kbyte)		128	128	128
SRAM (Kbyte)		16	16	16
Timers	Advanced control	1 (16-bit)		
	General purpose	5 (16-bit) 1(32-bit)		
	Basic	2		
	Low-power	1		
	SysTick	1		
	Watchdog	2		
Comm. intefaces	SPI[I2S]	2[2]		
	I2C	2		
	USART	4		
	CAN	1		
	USB	1		
DMA		7 ch		
RTC		Yes		

Peripheral	PY32F072Rx(64pin)	PY32F072Cx(48pin)	PY32F072Kx(32pin)
Universal Port	58	42	28
12-bit ADC channels (external + internal)	1 (16 + 8)	1 (13 + 8)	1 (10 + 8)
12-bit DAC (number of channels)	1 (2)		
COMP	3		
OPA	3		
LCD	1		
Max. CPU frequency	72 MHz		
Operating voltage	1.7 - 5.5 V		
Operating temperature	-40 to 85 ℃		
Packages	LQFP64,QFN64	LQFP48,QFN48	QFN32
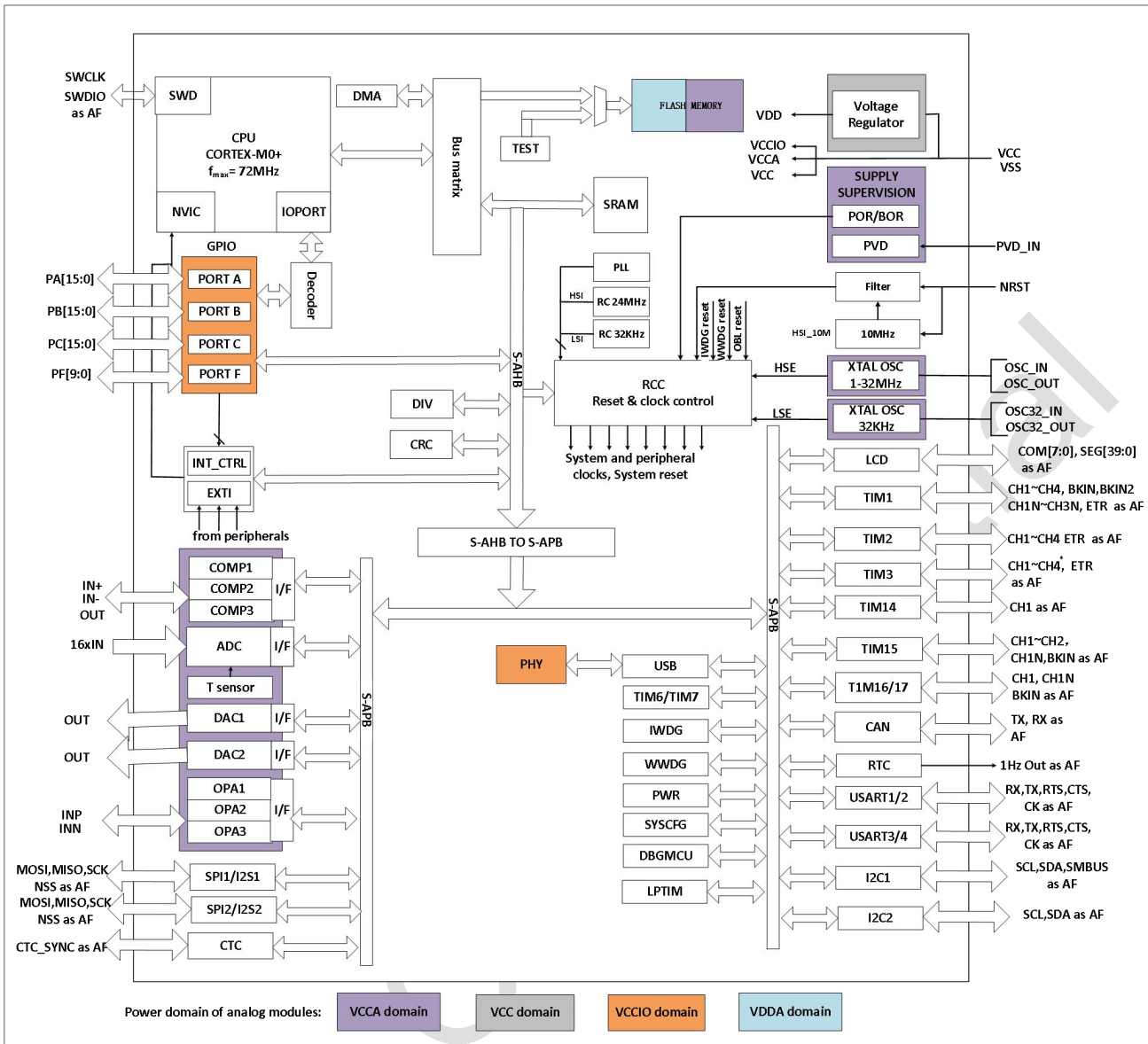
Figure 1- 1 System block diagram

2. Functional Overview

2.1. Arm®-Cortex®-M0+ core

The Arm® Cortex® -M0+ is an entry-level Arm 32-bit Cortex processor designed for a wide range of embedded applications. It provides developers with significant benefits, including:

- Simple structure, easy to learn and program

- Ultra-low power consumption, energy-saving operation

- Reduced code density and more

Cortex-M0+ processor is a 32-bit core optimized for area and power consumption and is a 2-stage pipeline Von Neumann architecture. The processor offers high-end processing hardware, including single-cycle multipliers, through a streamlined but powerful instruction set and an extensively optimized design. Moreover, it delivers the superior performance expected from a 32-bit architecture computer, with a higher coding density than other 8 and 16-bit microcontrollers.

The Cortex-M0+ is tightly coupled with a Nested Vectored Interrupt Controller (NVIC).

2.2. Memories

The on-chip integrated SRAM is accessed by bytes (8 bits), half-word (16 bits) or word (32 bits).

The on-chip integrated Flash consists of two different physical areas:

- Main flash area contains application and user data

- Information area has 14 kbytes, and it includes the following parts:
  - Option bytes
  - UID bytes
  - System memory

The protection of Flash main memory includes the following mechanisms:

- Read protection (RDP) prevents outside access.

- Wrtie protection (WRP) prevents unwanted write operation (confuse by program memory pointer from PC). The minimum protection unit for write protection is 8 Kbytes .

- Option byte write protection is a special design for unlock.

2.3. Boot modes

At startup, the BOOT0 pin and boot selector option bit nBOOT are used to select one of the three boot options in the following table:

Table 2- 1 Boot configuration

Boot mode configuration		Mode
nBOOT1 bit	BOOT0 pin	
X	0	Main Flash as the boot area
1	1	System memory as the boot area
0	1	SRAM as the boot area

The Boot loader is located in the System memory and is used to download the Flash program through the USART interface.

2.4. Clock system

At startup, the default system clock frequency is HSI 8 MHz, and after the program is operating the system clock frequency and system clock source can be reconfigured. The high frequency clocks that can be selected are:

■ A 4/8/16/22.12/24 MHz configurable internal high precision HSI clock

■ A 32.768 kHz configurable internal LSI clock

■ A 4 to 32 MHz HSE clock, and used to enable the CSS function to detect HSE. If CSS fails, the hardware will automatically convert the system clock to HSI, and software configures the HSI frequency. Simultaneously, CPU NMI interrupt is generated.

■ A 32.768 kHz LSE clock.

■ PLL clock has HSI and HSE sources. If the HSE source is selected, when CSS is enabled and CSS fails, the PLL and HSE will be turned off, and the hardware selects the system clock source as HSI.

The AHB clock can be divided based on the system clock, and the APB clock can be divided based on the AHB clock. AHB and APB clock frequencies up to 72 MHz.
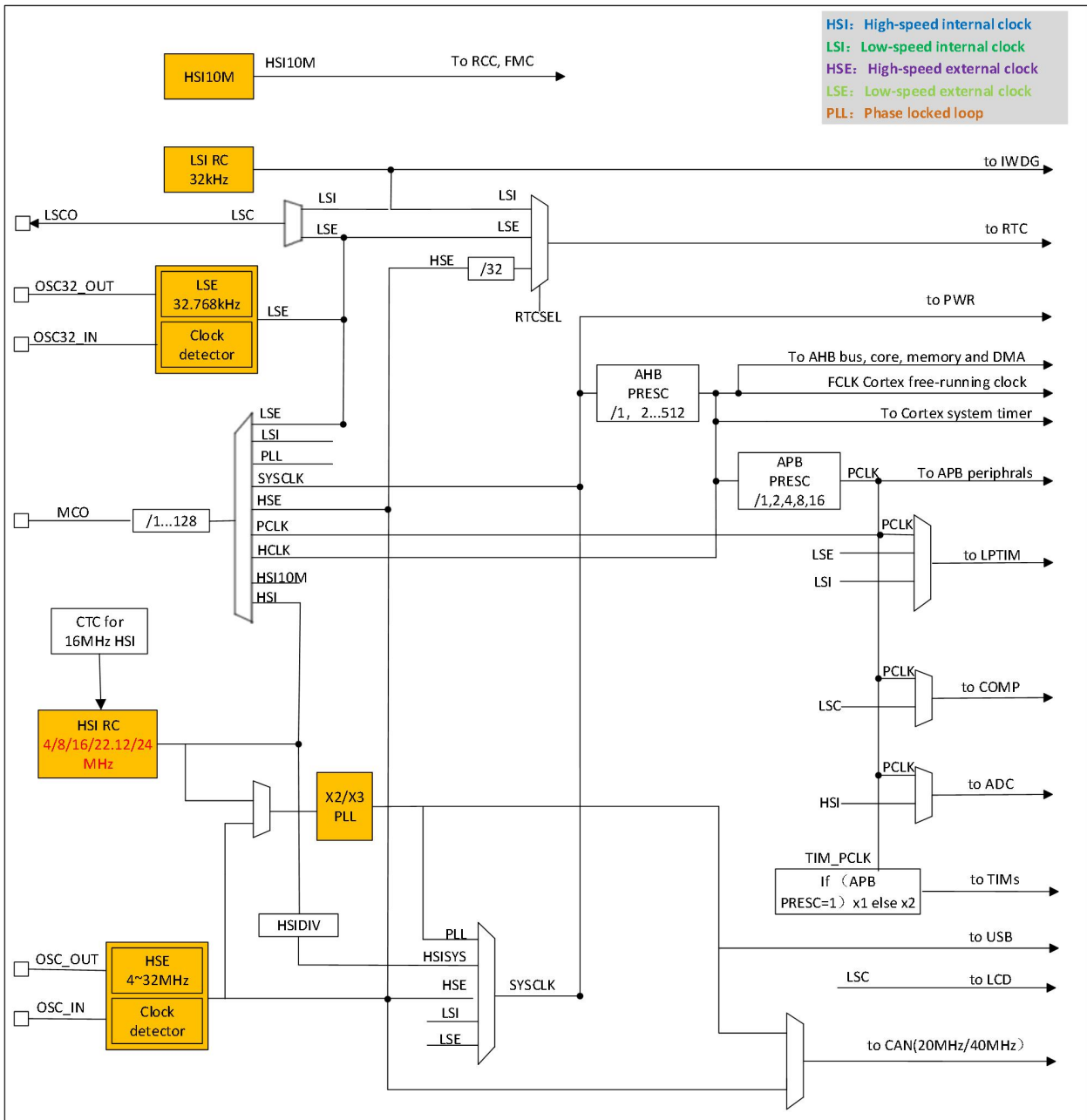
Figure 2- 1 System Clock Structure Diagram

2.5. Power management

2.5.1. Power block diagram
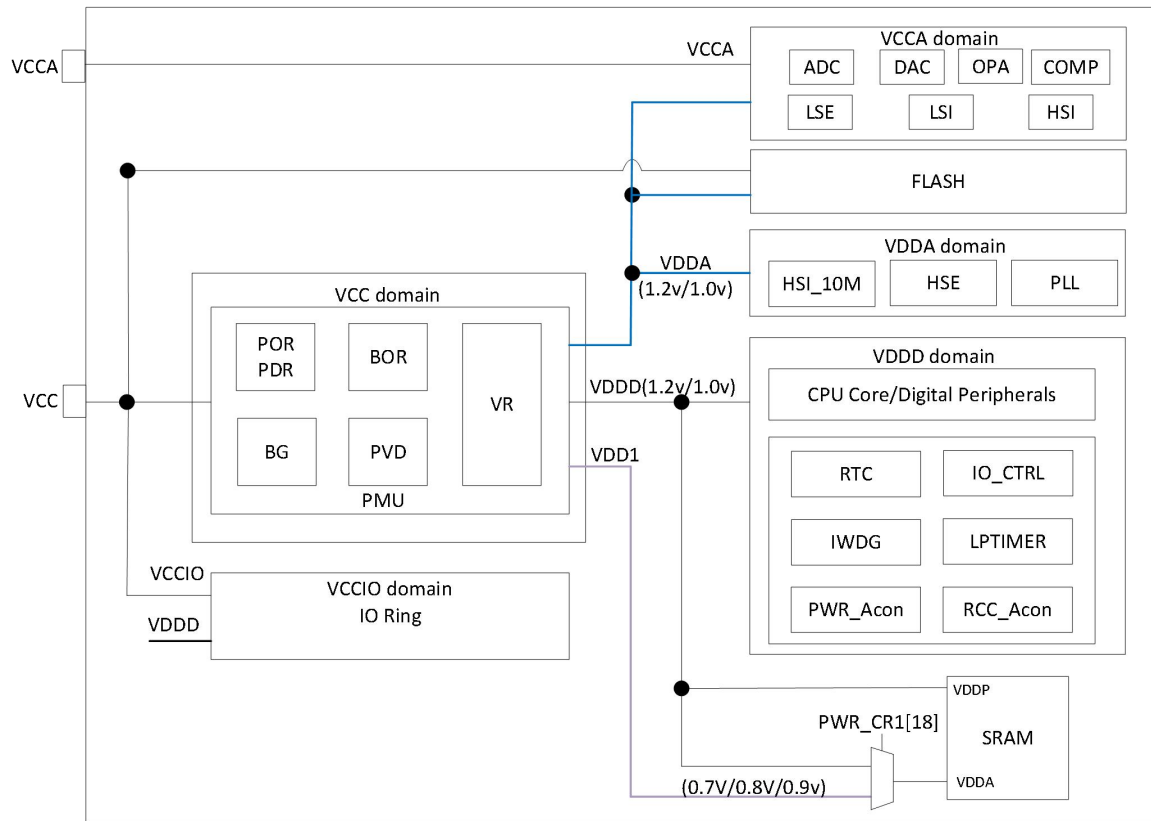
Figure 2- 2 Power block diagram

Table 2- 2 Power Block Diagram

Numbering	Power supply	Power value	Describe
1	V$_{CC}$	1.7 to 5.5 V	The chip is supplied power through the power pins.
2	V$_{DDD}$	1.2/1.0 V ± 10 %	VR supplies power to the main logic circuits and SRAM inside the chip. When the MR is powered, it outputs 1.2 V. According to the software configuration, when entering the stop mode it powered by MR or LPR, and the LPR output is determined to be 1.2 V or 1.0 V.
3	V$_{CCA}$	1.7 to 5.5 V	The chip is supplied analog power through the power pins.

2.5.2. Power monitoring

2.5.2.1. Power on reset (POR/PDR)

The power-on reset (POR) and power-down reset (PDR) module is designed in the chip to provide power-on and power-off reset for the chip. The module keeps working in all modes.

2.5.2.2. Brown-out reset (BOR)

In addition to POR/ PDR, BOR (brown-out reset) is also implemented. BOR can only be enabled and disabled through the option byte .

When the BOR is turned on, the BOR threshold can be selected by the Option byte, and both the rising and falling detection points can be configured individually.
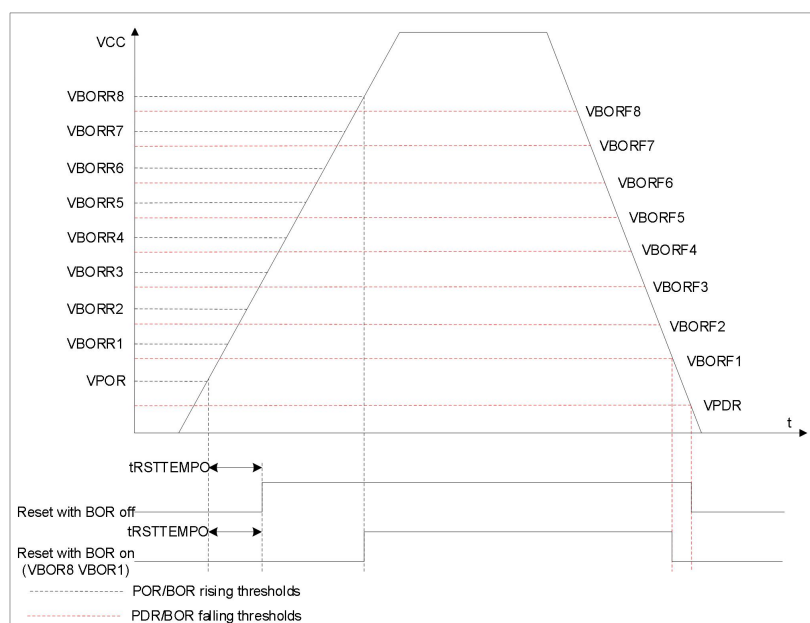
Figure 2- 3 POR/PDR/BOR threshold

2.5.2.3. Programmable voltage detection (PVD)

Programmable voltage detector (PVD) module can be used to detect the V_{CC} power supply and the voltage of the PB7 pin, and the detection point is configured through the register. When V_{CC} is higher or lower than the detection point of PVD , the corresponding reset flag is generated.

This event is internally connected to line 16 of EXTI , depending on the rising/falling edge configuration of EXTI line 16, when V_{CC} rises above the detection point of PVD, or V_{CC} falls below the detection point of PVD, an interrupt is generated. In the service program, users can perform urgent shutdown tasks.
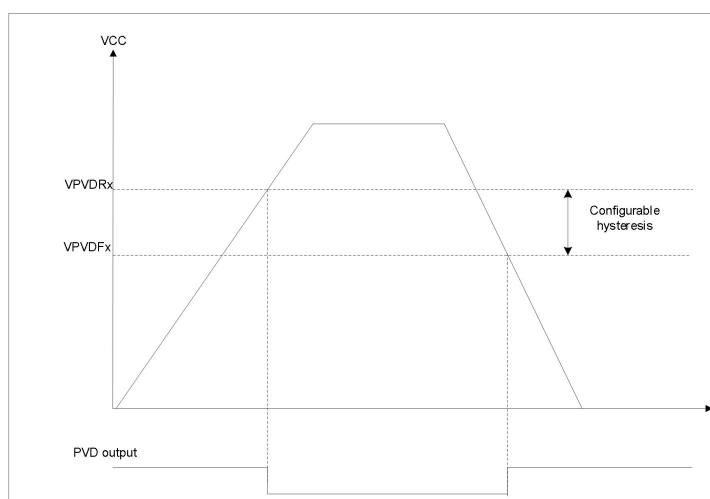
Figure 2- 4 PVD threshold

2.5.3. Voltage regulator

The regulator has two operating modes:

■ Main regulator (MR) is used in normal operating mode.

■ Low power regulator (LPR) can be used in Stop mode where the power demand is reduced.

2.5.4. Low-power mode

In addition to the normal operating mode, the chip has 2 low-power modes:

■ Sleep mode: Peripherals can be configured to keep working when the CPU clock is off (NVIC, SysTick, etc.). It is recommended only to enable the modules that must work, and close the module after the module works.

■ Stop mode: In this mode, the contents of SRAM and registers are maintained, HSI and HSE are turned off, and most modules of clocks in the VDD domain are stopped. GPIO, PVD, COMP output, RTC and LPTIM can wake up stop mode.

2.6. Reset

Two resets are designed in the chip: power reset and system reset.

2.6.1. Power reset

A power reset occurs in the following situations:

■ Power-on/power-down reset (POR/PDR)

■ Brown-out Reset (BOR)

2.6.2. System reset

A system reset occurs when the following events occur:

■ Reset of NRST pin

■ Windowed watchdog reset (WWDG)

- Independent watchdog reset (IWDG)
- SYSRESETREQ software reset
- Option byte load reset (OBL)
- Power reset (POR/PDR, BOR)

2.7. General-purpose inputs and outputs (GPIOs)

Each of the GPIO pins can be configured by software as output (push-pull or open-drain), as input (with or without pull-up or pull-down) or as peripheral alternate function, locking mechanism will freeze I/Os configuration function .

2.8. Hardware divider (DIV)

Hardware divider is a 32-bit signed/unsigned integer hardware divider.

DIV feture:

- Configurable signed/unsigned integer division calculation
- 32-bit dividend, 32-bit divisor
- Output 32-bit quotient and 32-bit remainder
- Division zero warning flag, division end flag
- 8 clock cycles to complete a division operation
- Write the divisor register to trigger the division operation to start
- Automatically wait for the end of the calculation when reading the quotient register/remainder register

2.9. Direct memory access controller (DMA)

Direct memory access (DMA) is used to provide high-speed data transfer between peripherals and memory or between memory and memory. Data can be moved quickly through DMA without CPU intervention, which saves CPU resources for other operations. The DMA controller has seven channels, each dedicated to managing requests for memory access from one or more peripherals. There is also a mediator to coordinate the priority of individual DMA requests.

The main functions are as follows:

- Single AHB master
- Support peripherals to memory, the memory to the peripherals, memory to memory and peripherals to peripheral data transmission
- On-chip memory devices, such as FLASH, an SRAM, AHB and APB peripherals, as the source and target
- All DMA channel can be independent configuration:
  - Each channel is associated either with a DMA request signal from a peripheral or with a software trigger in a memory-to-memory transfer. This configuration is done by software.

- The priority between requests is programmable by software (4 levels per channel: very high, high, medium, low) and, in equal cases, by hardware (such as a request for channel 1 taking precedence over a request for channel 2).

- The transfer sizes of the source and destination are independent (byte, half word, word), simulating packing and unpacking. The source and destination addresses must be aligned by data size.

- Programmable data transmission: 0 ~ 65535

■ Each channel generates an interrupt request. Each interrupt request is caused by one of three DMA events: transfer completion, half-transfer, or transfer error.

2.10. Interrupts and events

The PY32F072 handles exceptions through the Cortex-M0+ processor's embedded a nested vectored interrupt controller (NVIC) and an extended interrupt/event controller (EXTI).

2.10.1. Nested vectored interrupt controller (NVIC)

NVIC is a tightly coupled IP inside the Cortex-M0+ processor. The NVIC can handle NMI (Non-Maskable Interrupts) and maskable external interrupts from outside the processor and Cortex-M0+ internal exceptions. NVIC provides flexible priority management.

The tight coupling of the processor core to the NVIC greatly reduces the delay between an interrupt event and the initiation of the corresponding interrupt service routine (ISR). The ISR vectors are listed in a vector table, stored at a base address of the NVIC. The vector table base address determines the vector address of the ISR to execute, and the ISR is used as the offset composed of serial numbers.

If a high-priority interrupt event occurs and a low-priority interrupt event is just waiting to be serviced, the later-arriving high-priority interrupt event will be serviced first. Another optimization is called tail-chaining. When returning from a high-priority ISR and then starting a pending low-priority ISR, unnecessary pushes and pops of processor contexts will be skipped. This reduces latency and improves power efficiency.

NVIC features:

■ Low latency interrupt handling

■ Level 4 interrupt priority

■ Supports one NMI interrupt

■ Support 32 maskable external interrupts

■ Supports 10 Cortex-M0+ exceptions

■ High-priority interrupts can interrupt low-priority interrupt responses

■ Support tail-chaining optimization

■ Hardware interrupt vector retrieval

2.10.2. Extended interrupt/event controller (EXTI)

EXTI adds flexibility to handle physical wire events and generates wake-up events when the processor wakes up from stop mode.

The EXTI controller has multiple channels, including a maximum of 16 GPIOs, 1 PVD output, 3 COMP outputs, RTC and LPTIM wake-up signals. GPIO, PVD and COMP can be configured to be triggered by a rising edge, falling edge or double edge. Any GPIO signal can be configured as EXTI0 to 15 channel through the select signal.

- Each EXTI line can be independently masked through registers.

- The EXTI controller can capture pulses shorter than the internal clock period.

- Registers in the EXTI controller latch each event. Even in stop mode, after the processor wakes up from stop mode, it can identify the wake-up source or identify the GPIO and event that caused the interrupt.

2.11. Analog-to-digital converter (ADC)

The chip has a 12-bit SARADC. The module has up to 18 channels to be measured, including 16 external channels and 8 internal channels. The reference voltage can be selected with precision voltage (1.5 V, 2.048 V or 2.5 V) or the power supply voltage.

- The conversion mode of each channel can be set to single, continuous, sweep, discontinuous mode. Conversion results are stored in left or right-aligned 16-bit data registers.

- An analogue watchdog allows the application to detect if the input voltage exceeds a user-defined high or low threshold.

- The ADC has been implemented to operate at a low frequency, resulting in lower power consumption.

- At the end of sampling, conversion, and continuous conversion, an interrupt request is generated when the conversion voltage exceeds the threshold when simulating the watchdog.

2.12. Digital-to-analog converter (DAC)

Digital/analog conversion module (DAC) is a 12-bit digital input, voltage output digital/analog converter. The DAC can be configured in 8-bit or 12-bit mode, or can be used in conjunction with a DMA controller. When the DAC is operating in 12-bit mode, the data can be left justified or right justified. The DAC module has two output channels, each with a separate converter. In dual-DAC mode, the two channels can be converted independently, or they can be converted simultaneously and update the output of the two channels synchronously. The main features are as follows:

- 12 mode data left or right aligned

- synchronous update functionality

- waveform generating noise

- triangle waveform generation

- dual DAC channel or respectively at the same time

- each channel has the DMA function

- support DMA underflow error detection

- external triggers the transformation

2.13. Comparators (COMP)

Three general purpose comparators are integrated in the chip, namely COMP1/2/3. These two or three modules can be used as separate modules or combined with timer.

Comparators can be used as follows:

- Triggered by analog signal to generate low-power mode wake-up function

- Analog signal conditioning

- Cycle by cycle current control loop when connected with PWM output from timer

2.14. Operational amplifier (OPA)

The OPA1/2/3 module can be flexibly configured and is suitable for simple amplifiers. The three internal opamps can be cascaded using external resistors.

OPA features are summarized as follows:

- Three independently configured operational amps

- OPA input range is 0 to AV_{CC}, output range is 0.1 V to AV_{CC} - 0.2 V (demand) to simulate a module, a programmable gain

- Can be configured for the following models

- General operational mode (general purpose OPA)

- DAC voltage follower

2.15. Liquid crystal display (LCD) controller

The LCD controller is a digital controller/driver for monochrome passive liquid crystal displays (LCDS), with up to 8 common terminals (COM) and 40 segment terminals (SEG) to drive 160 (4 * 40) or 288 (8 * 36) LCD image elements. The exact number of terminals depends on the device pins described in the data manual. LCD functions are summarized as follows:

- Highly flexible frame rate control

- Support static, 1/2, 1/3, 1/4, 1/6, and 1/8 of a duty ratio

- Support 1/2, 1/3 bias voltage

- Up to 16 registers LCD data RAM

- By software configuration of LCD contrast

- 3 kinds of waveform generation

    - internal resistance pressure resistance, external pressure, external capacitance partial pressure

> — by way of internal resistance of the software configuration partial pressure power consumption, so as to match the capacitance charge needed for the LCD panel

■ Support low power consumption modes: LCD controller can be on the run, Sleep and stop mode for display

■ Configurable frame interrupt

■ Support LCD flashing function and configuration of multiple flicker frequency

■ Unused LCD segments and public pin can be configured to digital or analog functions

2.16. Timer

The characteristics of different timers of PY32F072 series are shown in the following table:

Table 2- 3 Timer features comparsion

Timer type	Timer	Counter resolution	Counter type	Prescaler factor	DMA	Capture /compare channels	Complementary outputs
Advanced control	TIM1	16-bit	Up, down, center aligned	Integer from 1 to 65536	Support	4	3
General purpose	TIM2	32-bit	Up, down, center aligned	Integer from 1 to 65536	Support	4	-
General purpose	TIM3	16-bit	Up, down, center aligned	Integer from 1 to 65536	Support	4	-
	TIM14	16-bit	Up	Integer from 1 to 65536	-	1	-
	TIM15	16-bit	Up	Integer from 1 to 65536	-	2	1
	TIM16, TIM17	16-bit	Up	Integer from 1 to 65536	Support	1	1
Basic	TIM6, TIM7	16-bit	Up	Integer from 1 to 65536	Support	-	-

2.16.1. Advanced-control timer (TIM1)

The advanced-control timer (TIM1) is consist of a 16-bit auto-reload counter driven by a programmable prescaler. It can be used in various scenarios, including pulse length measurement of input signals (input capture) or generating output waveforms (output compare, output PWM, complementary PWM with dead-time insertion).

TIM1 includes 4 independent channels:

— Input capture

— Output comparison

— PWM generation (edge or center-aligned mode)

— Single pulse mode output

If TIM1 is configured as a standard 16-bit timer, it has the same features as the TIMx timer. If configured as the 16-bit PWM generator, it has full modulation capability (0-100%).

The counter can can be frozen in debug mode.

Many features are shared with those of the standard timers which have the same architecture. The advanced control timer can therefore work together with the other timers by the Timer Link feature for synchronization or event chaining.

TIM1 supports the DMA function.

2.16.2. General-purpose timers

2.16.2.1. TIM2/TIM3

The general-purpose timers TIM2/TIM3 are consist of 32/16-bit auto-reload counters and a 32/16-bit prescaler. There are four independent channels each for input capture/output compare, PWM or one-pulse mode output.

■ They can work with the TIM1 by the Timer Link.

■ TIM2/TIM3 supports DMA function.

■ This timer is capable of handling quadrature (incremental) encoder signals and the digital outputs from 1 to 3 hall-effect sensors.

■ The counter can be frozen in debug mode.

2.16.2.2. TIM14

■ The general-purpose timer (TIM14) is consist of a 16-bit auto-reload counter driven by a programmable prescaler.

■ TIM14 features one single channel for input capture/output compare, PWM or one-pulse mode output.

■ The counter can be frozen in debug mode.

2.16.2.3. TIM15/TIM16/TIM17

■ The general-purpose timer (TIM15, TIM16 and TIM17) is consist of a 16-bit auto-reload counter driven by a programmable prescaler.

■ TIM16/TIM17 features one single channel for input capture/output compare, PWM or one-pulse mode output.

■ TIM15 features two single channel for input capture/output compare, PWM or one-pulse mode output.

■ TIM15/TIM16/TIM17 have complementary outputs with dead time.

■ TIM15/TIM16/TIM17 supports DMA function.

■ The counter can be frozen in debug mode.

2.16.3. Basic timers (TIM6/TIM7)

■ The basic timer (TIM6/TIM7) is consist of a 16-bit auto-reload upcounter driven by their programmable prescaler respectively.

■ Synchronization circuit to trigger DAC.

■ Generate interrupt/DMA request on update event (counter overflow).

2.16.4. Low power timer (LPTIM)

■ LPTIM is a 16 -bit upcounter with a 3-bit prescaler and only support a single count.

■ LPTIM can be configured as a stop mode wake-up source.

■ The counter can be frozen in debug mode.

2.16.5. Independent watchdog (IWDG)

Independent watchdog (IWDG) is integrated in the chip, and this module has the characteristics of high-security level, accurate timing and flexible use. IWDG finds and resolves functional confusion due to software failure and triggers a system reset when the counter reaches the specified timeout value.

■ The IWDG is clocked by LSI, so even if the main clock fails, it can keep working.

■ IWDG is the best suited for applications that require the watchdog as a standalone process outside of the main application and do not have high timing accuracy constraints.

■ Controlling of option byte can enable IWDG hardware mode.

■ IWDG is the wake-up source of stop mode, which wakes up stop mode by reset.

■ The counter can be frozen in debug mode.

2.16.6. System window watchdog (WWDG)

The system window watchdog is based on a 7-bit downcounter that can be set as free running. It can be used as a watchdog to reset the device when a problem occurs. It is clocked from the APB clock (PCLK). It has an early warning interrupt capability, and the counter can be frozen in debug mode.

2.16.7. SysTick timer

SysTick timer is dedicated to real-time operating systems, but could also be used as a standard downcounter.

SysTick Features:

■ 24-bit down counter

■ Auto-reload capability

■ Maskable system interrupt generation when the counter reaches 0

2.17. Real-time clock (RTC)

The real-time clock is an independent counter. It has a set of continuous counting counters, which can provide a clock calendar function under the corresponding software configuration. Modifying the value of the counter can reset the current time and date of the system.

■ RTC is a 32-bit programmable counter with a prescale factor of up to 2^{20} bits.

■ The RTC counter clock source can be LSE/LSI and the stop wake-up source.

■ RTC can generate alarm interrupt, second interrupt and overflow interrupt (maskable).

■ RTC supports clock calibration.

■ RTC can be frozen in debug mode.

2.18. Cyclic redundancy check cell(CRC)

CRC computing unit is based on a fixed generation polynomial to obtain 32-bit CRC computing results. In other applications, CRC technology is mainly used to verify the correctness and integrity of data transmission or data storage. CRC cell contains one 32-bit data register:

■ When writing to this register, as an input register, you can enter new data to perform CRC calculations.

■ When the register is read, the result of the last CRC calculation is returned.

■ Each time a data register is written, the result of the calculation is a combination of the previous CRC calculation and the new calculation (CRC calculation is performed on the entire 32-bit word rather than byte by byte).

■ You can RESET register CRC_DR to 0xFFFF by setting the reset bit of register CRC_CR. This operation does not affect the data in register CRC_IDR.

■ The initial CRC value can be configured.

2.19. Clock check system (CTC)

The clock calibration controller (CTC) uses hardware to automatically calibrate the RC crystal oscillator (HSI) when the internal configuration is 16 MHz, and uses the PLL (48 M) after 3 times the frequency as the clock source of the USBD module. The CTC module calibrates the HSI clock frequency based on an external high-precision reference signal source, and adjusts the calibration value automatically or manually to obtain an accurate PLL48 M clock.

The CTC module performs the following functions:

■ Three external reference sources: GPIO, LSE clock,USBD_SOF.

■ Provide software reference synchronization pulse.

■ Hardware calibration automatically, no software operation.

■ 16 bits calibration counter with reference source capture and overload capabilities.

■ 8 bits clock calibration base value for frequency evaluation and automatic calibration.

■ Flag bits and interrupts that indicate the state of clock calibration: calibration success state (CKOKIF), Warning state (CKWARNIF), and error state (ERRIF).

2.20. System configuration controller (SYSCFG)

The SYSCFG module provides the following functions:

- The filtering function on the IO pin of the _I^{2}C type was enabled or disabled

- Enable or disable filtering on all I/O pins

- Remap trigger sources for some Dmas to different DMA channels

- Remap memory at the beginning of the code interval (Boot)

- Manages the TIMERs ETR or brake input

2.21. Debug support (DBG)

The MCU DBG module assists the debugger with the following functions:

- Support sleep mode, stop mode and standby mode

- When the CPU enters the HALT mode, the control timer or watchdog stops counting or continues counting

- Block I^{2}C1 and I^{2}C2 SMBUS timeouts when the CPU is in HALT mode

- Block CAN's receive register from updating allocation tracking pins when the CPU enters HALT

- The MCUDBG register also provides chip ID encoding. This ID encoding can be accessed by a JTAG or SW debug interface, or by a user program.

2.22. Inter-integrated circuit interface (I^{2}C)

I^{2}C (inter-integrated circuit) bus interface connects the microcontroller and the serial I^{2}C bus. It provides multi-master capability and controls all I^{2}C bus specific sequences, protocols, arbitration and timing. Standard mode (Sm) and fast mode (Fm) are supported.

I^{2}C Features:

- Two I^{2}C Interface, support slave and master mode

- Multi-host function : can be master or slave

- Support different communication speeds

   — Standard Mode (Sm): Up to 100 kHz

   — Fast Mode (Fm): up to 400 kHz

- As master

   — Generate Clock

   — Generation of Start and Stop

- As slave

   — Programmable I^{2}C address detection

   — Dual-address capability that responds to two secondary addresses

   — Discovery of the Stop bit

- 7-bit/10-bit addressing mode

- General call

- Status flag

   — Transmit/receive mode flags

- — Byte transfer complete flag
- — I^{2}C busy flag bit
- ■ Error flag
  - — Master a rbitration loss
  - — ACK failure after address/data transfer
  - — Start/Stop error
  - — Overrun/Underrun (clock stretching function disable)
- ■ Optional clock stretching
- ■ Single-byte buffer with DMA capability
- ■ Software reset
- ■ Analog noise filter function
- ■ Support SMBus

2.23. Universal synchronous/asynchronous receiver transmitter (USART)

PY32F072 contains 4 USARTs, supports ISO7816, LIN, IrDA.

The USARTs provide a flexible method for full-duplex data exchange with external devices using the industry-standard NRZ asynchronous serial data format. The USART utilizes a fractional baudrate generator to provide a wide range of baudrate options.

It supports simultaneous one-way communication and half-duplex single-wire communication, and it also allows multi-processor communication.

Automatic baudrate detection is supported.

High-speed data communication can be achieved by using the DMA method of the multi-buffer configuration.

USARTs features:

- ■ Full-duplex asynchronous communication
- ■ NRZ standard format
- ■ Configurable 16 times or 8 times oversampling for increased flexibility in speed and clock tolerance
- ■ Programmable baudrate shared by transmit and receive, up to 4.5 Mbit/s
- ■ Automatic baudrate detection
- ■ Programmable data length of 8 or 9 bits
- ■ Configurable stop bits (0.5,1,1 or 2 bits)
- ■ Synchronous mode and clock output function for synchronous communication
- ■ Single-wire half-duplex communication
- ■ Independent transmit and receive enable bits
- ■ Hardware flow control
- ■ Receive/transmit bytes by DMA buffer
- ■ Detection flag

- — Receive full buffer

- — Send empty buffer

- — End of transmission

- Parity control

  - — Send check digit

  - — Check the received data

- Flagged interrupt sources

  - — CTS change

  - — Send empty register

  - — Send completed

  - — Receive full data register

  - — Bus idle detected

  - — Overflow error

  - — Frame error

  - — Noise operation

  - — Error detection

- Multiprocessor communication

  - — If the address does not match, enter silent mode

- Wake-up from silent mode: by idle detection and address flag detection

2.24. Serial peripheral interface (SPI)

PY32F072 contains two SPIs. SPIs allow the chip to communicate with external devices in half-duplex, full-duplex, and simplex synchronous serial communication. This interface can be configured in master mode and provides the communication clock (SCK) for external slave devices. The interface can also work in a multi-master configuration.

The SPI features are as follows:

- Master or slave mode

- 3-wire full-duplex simultaneous transmission

- 2-wire half-duplex synchronous transmission (with bidirectional data line)

- 2-wire simplex synchronous transmission (no bidirectional data line)

- 8-bit or 16-bit transmission frame selection

- Support multi-master mode

- 8 master mode baud rate prescale factors (max $f_{PCLK}/2$)

- Slave mode frequency (max $f_{PCLK}/4$)

- Both master and slave modes can be managed by software or hardware NSS: dynamic change of master/slave operating mode

- Programmable clock polarity and phase

- Programmable data order, MSB first or LSB first

- Dedicated transmit and receive flags that can trigger interrupts

- SPI bus busy status flag

- Motorola mode

- Interrupt-causing master mode faults, overloads

- Two 32-bit Rx and Tx FIFOs with DMA capability

2.25. USB2.0 full-speed module

PY32F072 contains 1 USB 2.0 full speed module. USB peripheral implements the interface between USB2.0 full speed bus and APB1 bus. Support USB suspend/restore operation, can stop the device clock to achieve low power consumption. The main features are as follows:

- Comply with the technical specifications of USB 2.0 full speed devices

- It can be configured with 1 to 6 USB endpoints

- CRC(cyclic redundancy check) generation/check, reverse non-return to zero (NRZI) encoding/decoding and bit filling

- Support control transmission/synchronous transmission/batch transmission/interrupt transmission

- Supports a dual buffer mechanism for batch/synchronous endpoints

- USB suspend and restore operations are supported

- Frame lock clock pulse generation

- Dedicated 1024-byte packet cache storage

2.26. CAN

PY32F072 contains one CAN communication interface module. The Controller Area Network (CAN) bus is a bus standard that can realize the communication between microprocessors or devices without a host.

The CAN bus controller CAN handle data sending and receiving on the bus. In this product, the CAN controller has 12 groups of filters. Filters are used to select messages for the application to receive. The application program in the CAN controller can Transmit 1 Primary Transmit Buffer (PTB) and 3 Secondary Transmit buffers (PTB) STB) sends the sending data to the bus, and the sending scheduler determines the sending order of the mailboxes. The bus data is obtained through three Receive buffers (RB). Three STBS and three RB can be interpreted as a level 3 FIFO and a Level 3 FIFO, where the FIFO is completely hardware controlled. The CAN bus controller also supports Time-trigger communication.

- Fully support ISO11898-1 CAN2.0A/ CAN2.0B protocol

- CAN2.0 supports a maximum communication baud rate of 1M bit/s

- The baud rate ranges from 1 to 1/256. The baud rate is flexibly configured

- Three receive buffers

  - FIFO mode

  - Error or unreceived data does not overwrite stored messages

- One high - priority primary send buffer PTB

- Three sub-send buffers STB

- — FIFO mode

- — Priority arbitration mode

- ■ 12 separate sets of filters

    - — It supports 11-bit standard ID and 29-bit extended ID

    - — Programmable ID CODE bit and MASK bit

- ■ Silent mode support

- ■ Supports loopback mode

- ■ Supports capturing transmission error types and locating quorum failure locations

- ■ Programmable error warning value

- ■ Support ISO11898-4 time trigger CAN and receive time stamp

2.27. Serial wire debug (SWD)

The ARM SWD interface allows serial debugging tools to be connected to the PY32F072.

3. Pin Configuration
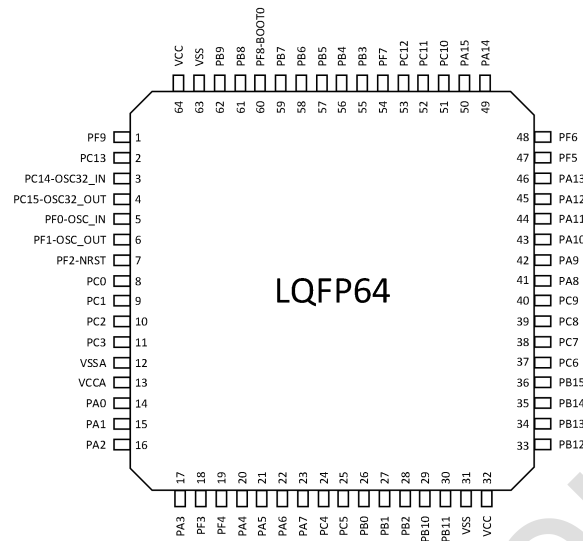
Figure 3- 1 LQFP64 PY32F072R1xT Pinout1
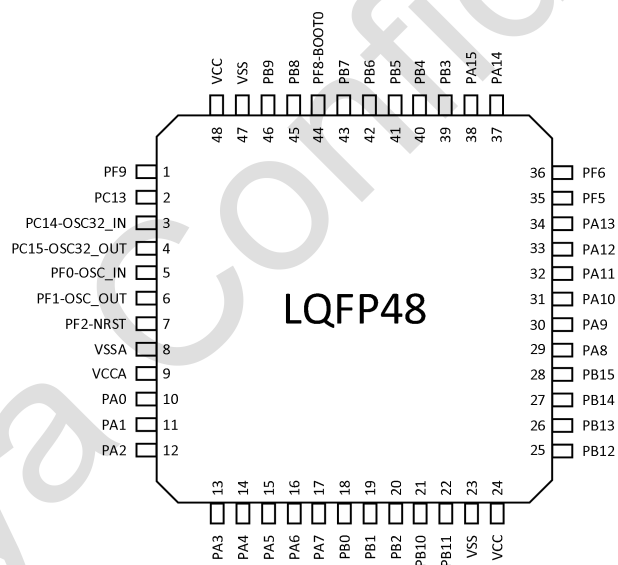
Figure 3- 2 LQFP48 PY32F072C1xT Pinout1
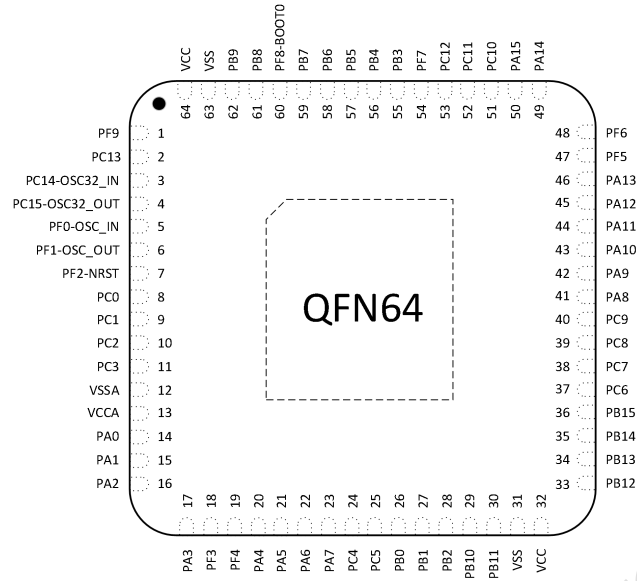
Figure 3- 3 QFN64 PY32F072R1xU Pinout1
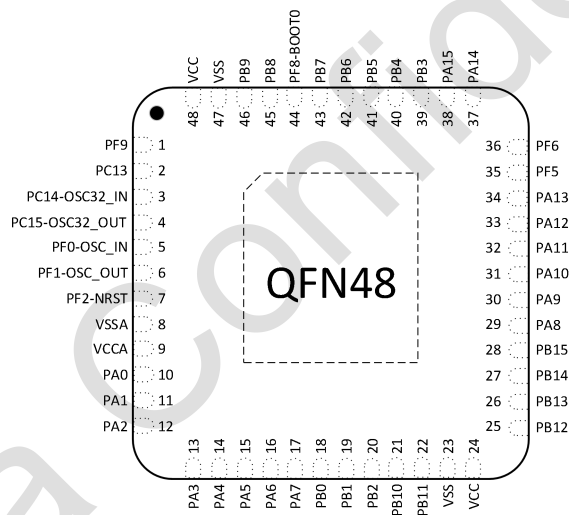
Figure 3- 4 QFN48 PY32F072C1xU Pinout1
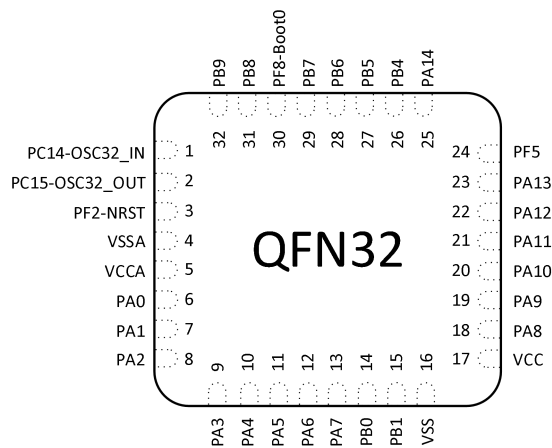
Figure 3- 4 QFN32 PY32F072K1xU Pinout1

Table 3- 1 Pin Definition Terminology and Symbols

Name		Symbol	Definition
Pin type		S	Supply pin
		G	Ground pin
		I	Input-only pin
		I/O	Input/output pin
I/O structure		COM	Normal 5V I/O with analog input and output function
		RST	Reset pin, with internal weak pull-up resistor, without analog input and output function
		COM F	I/O, I²C Fm+ capable with analog input and output function
		COM U	GPIO 5V tolerant with USB PHY function
Notes			Unless otherwise specified, all ports are used as floating inputs between and after reset
Pin function	Alternate functions		Function selected by GPIOx_AFR register
	Additional functions		Directly selected or enabled through peripheral registers

Table 3- 2 pin definition

package					Reset	Ports Type	Ports structure	Notes	Port Functions	
LQFP64 R1	LQFP48 C1	QFN64 R1	QFN48 C1	QFN32 K1					Alternate functions	Additional functions
1	1	1	1		PF9	I/O	COM		-	-
2	2	2	2		PC13	I/O	COM		SPI1_SCK/I²S1_CK	-
									TIM1_BKIN	
3	3	3	3	1	PC14	I/O	COM		TIM1_BKIN2	OSC32_IN
4	4	4	4	2	PC15	I/O	COM		TIM15_BKIN	OSC32_OUT
5	5	5	5		PF0-OSC_IN	I/O	COM		CTC_SYNC	OSC_IN
									USART2_TX	
									TIM1_BKIN	
									TIM14_CH1	
6	6	6	6		PF1-OSC_OUT	I/O	COM		USART2_RX	OSC_OUT
									TIM1_CH1N	
									TIM15_CH1N	
7	7	7	7	3	PF2-NRST	I/O	RST		TIM1_CH2	-
									EVENTOUT	
									MCO	
8		8			PC0	I/O	COM		EVENTOUT	ADC_IN10, COMP1_INP0, COMP2_INN0, SEG27
									SPI1_MISO/I²S1_MCK	
									USART2_CTS	

package					Reset	Ports Type	Ports structure	Notes	Port Functions	
LQFP64 R1	LQFP48 C1	QFN64 R1	QFN48 C1	QFN32 K1					Alternate functions	Additional functions
									USART3_RTS	
9		9			PC1	I/O	COM		EVENTOUT	ADC_IN11, COMP1_INP1, COMP2_INN1, SEG26
									SPI1_MOSI/I²S1_SD	
									USART2_RTS	
									USART3_CTS	
									TIM15_CH1	
10		10			PC2	I/O	COM		EVENTOUT	ADC_IN12, COMP1_INP2, COMP2_INN2, SEG25
									SPI2_MISO/I²S2_MCK	
									USART3_TX	
									USART3_RX	
									TIM15_CH2	
11		11			PC3	I/O	COM		EVENTOUT	ADC_IN13, COMP1_INP3, COMP2_INN3, SEG24
									SPI2_MOSI/I²S2_SD	
									USART3_RX	
									USART3_TX	
12	8	12	8	4	V$_{SSA}$	G			Ground	
13	9	13	9	5	V$_{CCA}$	S			Analog power supply	
14	10	14	10	6	PA0	I/O	COM		USART2_CTS	ADC_IN0, COMP1_INP4, COMP1_INN0, COMP2_INP0, COMP2_INN4, SEG23
									TIM2_CH1_ETR	
									USART4_TX	
									COMP1_OUT	
									SPI2_SCK	
15	11	15	11	7	PA1	I/O	COM		EVENTOUT	ADC_IN1, COMP1_INP5, COMP1_INN1, COMP2_INP1, COMP2_INN5, SEG22
									USART2_RTS	
									TIM2_CH2	
									USART4_RX	
									TIM15_CH1N	
									I²C1_SMBA	
									SPI1_SCK/I²S1_CK	
									SPI2_MOSI	
16	12	16	12	8	PA2	I/O	COM		TIM15_CH1	ADC_IN2, COMP1_INP6, COMP1_INN2, COMP2_INP2, SEG21
									USART2_TX	
									TIM2_CH3	
									COMP2_OUT	
									SPI1_MOSI/I²S1_SD	
									SPI2_MISO	
17	13	17	13	9	PA3	I/O	COM		EVENTOUT	ADC_IN3, COMP1_INP7, COMP1_INN3, COMP2_INP3, SEG20
									TIM15_CH2	
									USART2_RX	
									TIM2_CH4	

package					Reset	Ports Type	Ports structure	Notes	Port Functions	
LQFP64 R1	LQFP48 C1	QFN64 R1	QFN48 C1	QFN32 K1					Alternate functions	Additional functions
									SPI2_MISO	
									SPI2_NSS/I²S2_WS	
18		18			PF3	I/O	COM_F		EVENTOUT	-
									I²C1_SCL	
									I²C2_SCL	
19		19			PF4	I/O	COM_F		I²C1_SDA	-
									I²C2_SDA	
20	14	20	14	10	PA4	I/O	COM		EVENTOUT	ADC_IN4, DAC_OUT1, COMP1_INP8, COMP1_INN4, COMP2_INP4, SEG19
									SPI1_NSS/I²S1_WS	
									USART2_CK	
									TIM14_CH1	
									SPI2_MOSI	
									USART2_TX	
									PVD_OUT	
21	15	21	15	11	PA5	I/O	COM		EVENTOUT	ADC_IN5, DAC_OUT2, COMP1_INP9, COMP1_INN5, COMP2_INP9, ...
									SPI1_SCK/ I²S1_CK	
									TIM2_CH1_ETR	
									USART3_TX	
22	16	22	16	12	PA6	I/O	COM		EVENTOUT	ADC_IN6, COMP1_INP10, COMP1_INN6, OPA2_INN, SEG17
									SPI1_MISO/I²S1_MCK	
									TIM3_CH1	
									TIM1_BKIN	
									USART3_CTS	
									TIM16_CH1	
									COMP1_OUT	
23	17	23	17	13	PA7	I/O	COM		EVENTOUT	ADC_IN7, COMP1_INP11, COMP1_INN7, OPA2_INP, SEG16
									SPI1_MOSI/I²S1_SD	
									TIM3_CH2	
									TIM1_CH1N	
									TIM14_CH1	
									TIM17_CH1	
									COMP2_OUT	
24		24			PC4	I/O	COM		EVENTOUT	ADC_IN14, COMP1_INN8, SEG15
									USART3_TX	
									COMP3_OUT	
									SPI1_NSS/I²S1_WS	
									USART1_TX	
									TIM2_CH1_ETR	
									IR_OUT	
25		25			PC5	I/O	COM		USART3_RX	ADC_IN15, COMP1_INN9, SEG14
									SPI1_MOSI/I²S1_SD	

package					Reset	Ports Type	Ports structure	Notes	Port Functions	
LQFP64 R1	LQFP48 C1	QFN64 R1	QFN48 C1	QFN32 K1					Alternate functions	Additional functions
									USART1_RX	
									TIM2_CH2	
26	18	26	18	14	PB0	I/O	COM		EVENTOUT	ADC_IN8, COMP2_INN6, COM2
									TIM3_CH3	
									TIM1_CH2N	
									USART3_CK	
									COMP1_OUT	
									SPI1_NSS/I^{2}S1_WS	
									USART3_RX	
27	19	27	19	15	PB1	I/O	COM		EVENTOUT	ADC_IN9, COMP2_INP6, COMP2_INN7, COMP3_INP1, COMP3_INN1, SEG12
									TIM14_CH1	
									TIM3_CH4	
									TIM1_CH3N	
									USART3_RTS	
									COMP3_OUT	
28	20	28	20		PB2	I/O	COM		EVENTOUT	COMP2_INP7, COMP2_INN8, SEG11
									SPI2_MISO	
									USART3_TX	
29	21	29	21		PB10	I/O	COM_F		I^{2}C2_SCL	COMP2_INP8, SEG10
									TIM2_CH3	
									USART3_TX	
									SPI2_SCK/I^{2}S2_CK	
									COMP1_OUT	
									USART2_RTS	
									I^{2}C1_SCL	
30	22	30	22		PB11	I/O	COM_F		EVENTOUT	COMP3_INP8, COMP3_INN4, SEG9
									I^{2}C2_SDA	
									TIM2_CH4	
									USART3_RX	
									COMP2_OUT	
									SPI2_MOSI	
									USART2_CTS	
									I^{2}C1_SDA	
31	23	31	23	16	V$_{SS}$	G			Ground	
32	24	32	24	17	V$_{CC}$	S			Digital power supply	
33	25	33	25		PB12	I/O	COM		EVENTOUT	COMP2_INP9, OPA3_INN, SEG8
									SPI2_NSS/I^{2}S2_WS	
									TIM1_BKIN	
									USART3_CK	
									TIM15_BKIN	
34	26	34	26		PB13	I/O	COM_F		EVENTOUT	COMP2_INP10, OPA3_INP

package					Reset	Ports Type	Ports structure	Notes	Port Functions	
LQFP64 R1	LQFP48 C1	QFN64 R1	QFN48 C1	QFN32 K1					Alternate functions	Additional functions
									SPI2_SCK/I^{2}S2_CK	
									TIM1_CH1N	
									USART3_CTS	
									I^{2}C2_SCL	
									MCO	
									TIM15_CH1N	
									I^{2}C1_SCL	
35	27	35	27		PB14	I/O	COM_F		EVENTOUT	COMP2_INP11, COMP3_INP9, COMP3_INN5, OPA3_OUT, SEG6
									SPI2_MISO/I^{2}S2_MCK	
									TIM15_CH1	
									TIM1_CH2N	
									USART3_RTS	
									I^{2}C2_SDA	
									I^{2}C1_SDA	
36	28	36	28		PB15	I/O	COM		EVENTOUT	SEG5
									SPI2_MOSI/I^{2}S2_SD	
									TIM15_CH2	
									TIM1_CH3N	
									TIM15_CH1N	
37		37			PC6	I/O	COM		TIM3_CH1	SEG4
									SPI2_SCK/I^{2}S2_CK	
									USART4_RX	
									TIM2_CH3	
38		38			PC7	I/O	COM		TIM3_CH2	COMP3_INP13, COMP3_INN8, SEG3
									SPI2_MISO/I^{2}S2_MCK	
									USART4_TX	
									TIM2_CH4	
39		39			PC8	I/O	COM		TIM3_CH3	SEG2
									SPI2_MOSI/I^{2}S2_SD	
									USART4_CTS	
									TIM1_CH1	
40		40			PC9	I/O	COM		TIM3_CH4	SEG1
									SPI2_NSS/I^{2}S2_WS	
									I^{2}S1_CKIN	
									USART4_RTS	
									TIM1_CH2	
41	29	41	29	18	PA8	I/O	COM		EVENTOUT	SEG0, OPA1_OUT
									MCO	
									USART1_CK	
									TIM1_CH1	
									CTC_SYNC	

package					Reset	Ports Type	Ports structure	Notes	Port Functions	
LQFP64 R1	LQFP48 C1	QFN64 R1	QFN48 C1	QFN32 K1					Alternate functions	Additional functions
									SPI2_NSS	
									USART1_TX	
42	30	42	30	19	PA9	I/O	COM_F		EVENTOUT	COM0, OPA1_INP
									TIM15_BKIN	
									USART1_TX	
									TIM1_CH2	
									I²C1_SCL	
									SPI2_MISO	
									MCO	
									I²C2_SCL	
43	31	43	31	20	PA10	I/O	COM_F		EVENTOUT	COM1, OPA1_INN
									TIM17_BKIN	
									USART1_RX	
									TIM1_CH3	
									I²C1_SDA	
									SPI2_MOSI	
									I²C2_SDA	
44	32	44	32	21	PA11	I/O	COM_U		EVENTOUT	USB_DM, SEG13, CAN_RX
									USART1_CTS	
									TIM1_CH4	
									COMP1_OUT	
									SPI1_MISO/I²S1_MCK	
45	33	45	33	22	PA12	I/O	COM_U		EVENTOUT	USB_DP, SEG12, CAN_TX
									USART1_RTS	
									TIM1_ETR	
									COMP2_OUT	
									SPI1_MOSI/I²S1_SD	
									I²S1_CKIN	
46	34	46	34	23	PA13	I/O	COM		EVENTOUT	-
									SWDIO	
									IR_OUT	
									USART1_RX	
									COMP3_OUT	
									PVD_OUT	
47	35	47	35	24	PF5	I/O	COM		TIM1_BKIN2	RTC_OUT
48	36	48	36		PF6	I/O	COM		USART1_CTS	-
49	37	49	37	25	PA14	I/O	COM		EVENTOUT	-
									SWCLK	
									USART2_TX	
									USART1_TX	

package									Port Functions	
LQFP64 R1	LQFP48 C1	QFN64 R1	QFN48 C1	QFN32 K1	Reset	Ports Type	Ports structure	Notes	Alternate functions	Additional functions
									PVD_OUT	
50	38	50	38		PA15	I/O	COM		EVENTOUT	-
									SPI1_NSS/I²S1_WS	
									USART2_RX	
									TIM2_CH1_ETR	
									USART4_RTS	
									USART3_RTS_DE_CK	
51		51			PC10	I/O	COM		USART4_TX	COM4/SEG39
									USART3_TX	
									TIM1_CH3	
52		52			PC11	I/O	COM		USART4_RX	COM5/SEG38
									USART3_RX	
									TIM1_CH4	
53		53			PC12	I/O	COM		USART4_CK	COM6/SEG37
									USART3_CK	
									TIM14_CH1	
54		54			PF7	I/O	COM		TIM3_ETR	COM7/SEG36
									USART3_RTS	
									TIM1_CH1N	
55	39	55	39		PB3	I/O	COM		EVENTOUT	COMP2_INN9, SEG35/VLCDH
									SPI1_SCK/I²S1_CK	
									TIM2_CH2	
									USART1_RTS_DE_CK	
									TIM1_CH2	
56	40	56	40	26	PB4	I/O	COM		EVENTOUT	COMP1_INP12, COMP2_INP12, SEG34/VLCD3
									SPI1_MISO/I²S1_MCK	
									TIM3_CH1	
									USART1_CTS	
									USART1_CK	
									TIM1_CH2N	
									TIM17_BKIN	
57	41	57	41	27	PB5	I/O	COM		SPI1_MOSI/I²S1_SD	COMP1_INP13, SEG33/VLCD2
									TIM3_CH2	
									TIM16_BKIN	
									I²C1_SMBA	
									USART1_CK	
									COMP2_OUT	
									USART1_RTS	
									USART1_TX	
									TIM1_CH3N	
58	42	58	42	28	PB6	I/O	COM_F		EVENTOUT	COMP1_INP14, COMP2_INP14

LQFP64 R1	LQFP48 C1	QFN64 R1	QFN48 C1	QFN32 K1	Reset	Ports Type	Ports structure	Notes	Alternate functions	Additional functions
package									Port Functions	
									USART1_TX	
									I²C1_SCL	
									TIM16_CH1N	
									SPI2_MISO	
									USART3_CTS	
									TIM1_CH3	
									I²C2_SCL	
59	43	59	43	29	PB7	I/O	COM_F		EVENTOUT	PVD_IN, COMP2_INP15, SEG31
									USART1_RX	
									I²C1_SDA	
									TIM17_CH1N	
									USART4_CTS	
									SPI2_MOSI	
									I²C2_SDA	
									TIM1_CH1	
60	44	60	44	30	PF8/BOOT	I/O	COM			SEG30
61	45	61	45	31	PB8	I/O	COM_F		EVENTOUT	SEG29, CAN_RX
									I²C1_SCL	
									I²C2_SCL	
									TIM16_CH1	
									SPI2_SCK	
									USART1_TX	
									USART3_TX	
									TIM15_BKIN	
									TIM1_CH1N	
62	46	62	46	32	PB9	I/O	COM_F		EVENTOUT	SEG28, CAN_TX
									IR_OUT	
									I²C1_SDA	
									TIM17_CH1	
									SPI2_NSS/I²S2_WS	
									USART1_RX	
									USART3_RX	
									I²C2_SDA	
63	47	63	47		V_SS	G			Ground	
64	48	64	48		V_CC	S			Digital power supply	

1. Configure by option bytes to choose PF2 or NRST.

2. After reset, PA13 and PA14 are configured as SWDIO and SWCLK AF functions, the former has an internal pull-up resistor and the latter has an internal pull-down resistor activated.

3. BOOT0 defaults to digital input mode and pull-down is enable.

3.1. PortA alternate function mapping

Table 3-3 PortA alternate function mapping

Port A	AF0	AF1	AF2	AF3	AF4	AF5	AF6	AF7	AF8	AF9	AF10	AF11	AF12	AF13	AF14	AF15
PA0	-	USART2_CTS	TIM2_CH1_ETR	-	USART4_TX	-	-	COMP1_OUT	SPI2_SCK	-	-	-	-	-	-	-
PA1	EVENTOUT	USART2_RTS	TIM2_CH2	-	USART4_RX	TIM15_CH1N	I²C1_SMBA	-	SPI1_SCK/I2S1_CK	SPI2_MOSI	-	-	-	-	-	-
PA2	TIM15_CH1	USART2_TX	TIM2_CH3	-	-	-	-	COM2_OUT	SPI1_MOSI/I2S1_SD	SPI2_MISO	-	-	-	-	-	-
PA3	TIM15_CH2	USART2_RX	TIM2_CH4	-	-	-	-	EVENTOUT	SPI2_MSIO	SPI2_NSS/I2S2_WS	-	-	-	-	-	-
PA4	SPI1_NSS/I2S1_WS	USART2_CK		-	TIM14_CH1	-	-	EVENTOUT	SPI2_MOSI	USART2_TX	-	-	PVD_OUT	-	-	-
PA5	SPI1_SCK/I2S1_CK	-	TIM2_CH1_ETR	-	-	-	-	EVENTOUT	-	-	USART3_TX	-	-	-	-	-
PA6	SPI1_MISO/I2S1_MCK	TIM3_CH1	TIM1_BKIN	-	USART3_CTS	TIM16_CH1	EVENTOUT	COMP1_OUT	-	-	-	-	-	-	-	-
PA7	SPI1_MOSI/I2S1_SD	TIM3_CH2	TIM1_CH1N	-	TIM14_CH1	TIM17_CH1	EVENTOUT	COMP2_OUT	-	-	-	-	-	-	-	-
PA8	MCO	USART1_CK	TIM1_CH1	EVENTOUT	CTC_SYNC	-	-	-	SPI2_NSS	-	USART1_TX	-	-	-	-	-
PA9	TIM15_BKIN	USART1_TX	TIM1_CH2	-	-	-	I²C1_SCL	EVENTOUT	SPI2_MISO	MCO	-	-	-	I²C2_SCL	-	-
PA10	TIM17_BKIN	USART1_RX	TIM1_CH3	-	-	-	I²C1_SDA	EVENTOUT	SPI2_MOSI	-	-	-	-	I²C2SDA	-	-
PA11	EVENTOUT	USART1_CTS	TIM1_CH4	-	CAN_RX	-	-	COMP1_OUT	SPI1_MISO/I2S1_MCK	-	-	TIM1_BKIN2	-	-	-	-
PA12	EVENTOUT	USART1_RTS	TIM1_ETR	-	CAN_TX	-	-	COMP2_OUT	SPI1_MOSI/I2S1_SD	I2S1_CKIN	-	-	-	-	-	-
PA13	SWDIO	IROUT	-	-	-	-	-	EVENTOUT	-	USART1_RX	-	COMP3_OUT	PVD_OUT	-	-	-
PA14	SWCLK	USART2_TX	-	-	-	-	-	EVENTOUT	-	USART1_TX	-	-	PVD_OUT	-	-	-

Port A	AF0	AF1	AF2	AF3	AF4	AF5	AF6	AF7	AF8	AF9	AF10	AF11	AF12	AF13	AF14	AF15
PA15	SPI1_NSS/I2S1_WS	USART2_RX	TIM2_CH1_ETR	EVENTOUT	USART4_RTS			EVENTOUT			USART3_RTS_DE_CK					

3.2. PortB alternate function mapping

Table 3- 4 Port B alternate function mapping

Port B	AF0	AF1	AF2	AF3	AF4	AF5	AF6	AF7	AF8	AF9	AF10	AF11	AF12	AF13	AF14	AF15
PB0	EVENTOUT	TIM3_CH3	TIM1_CH2N	-	USART3_CK	-	-	COMP1_OUT	SPI1_NSS/I2S1_WS	-	USART3_RX	-	-	-	-	-
PB1	TIM14_CH1	TIM3_CH4	TIM1_CH3N	-	USART3_RTS	-	-	EVENTOUT	-	-	-	COMP3_OUT	-	-	-	-
PB2	-	-	-	-	-	-	-	EVENTOUT	SPI2_MISO	-	USART3_TX	-	-	-	-	-
PB3	SPI1_SCK/I2S1_CK	EVENTOUT	TIM2_CH2	-	USART1_RTS	-	-	EVENTOUT	-	-	-	TIM1_CH2	-	-	-	-
PB4	SPI1_MISO/I2S1_MCK	TIM3_CH1	EVENTOUT	-	USART1_CTS	TIM17_BKIN	-	-	-	-	-	TIM1_CH2N	-	USART1_CK	-	-
PB5	SPI1_MOSI/I2S1_SD	Tim3_CH2	TIM16_BKIN	I2C1_SMBA	USART1_CK	-	-	COM2_OUT	-	USART1_RTS	-	TIM1_CH3N	-	USART1_TX	-	-
PB6	USART1_TX	I2C1_SCL	TIM16_CH1N	-	-	-	-	EVENTOUT	SPI2_MISO	-	USART3_CTS	TIM1_CH3	-	I2C2_SCL	-	-
PB7	USART1_RX	I2C1_SDA	TIM17_CH1N	-	USART4_CTS	-	-	EVENTOUT	SPI2_MOSI	-	-	TIM1_CH1	-	I2C2_SDA	-	-
PB8	-	I2C1_SCL	TIM16_CH1	-	CAN_RX	-	-	EVENTOUT	SPI2_SCK	USART1_TX	USART3_TX	TIM15_BKIN	-	I2C2_SCL	TIM1_CH1N	-
PB9	IR_OUT	I2C1_SDA	TIM17_CH1	EVENTOUT	CAN_TX	SPI2_NSS/I2S2_WS	-	-	-	USART1_RX	USART3_RX	-	-	I2C2_SDA	-	-
PB10	-	I2C2_SCL	TIM2_CH3	-	USART3_TX	SPI2_SCK/I2S2_CK	-	COMP1_OUT	-	USART2_RTS	-	-	-	I2C1_SCL	-	-
PB11	EVENTOUT	I2C2_SDA	TIM2_CH4	-	USART3_RX	-	-	COMP2_OUT	SPI2_MOSI	USART2_CTS	-	-	-	I2C1_SDA	-	-

Port B	AF0	AF1	AF2	AF3	AF4	AF5	AF6	AF7	AF8	AF9	AF10	AF11	AF12	AF13	AF14	AF15
PB12	SPI2_NSS/I2S2_WS	EVENTOUT	TIM1_BKIN	-	USART3_CK	TIM15_BKIN	-	-	-	-	-	-	-	-	-	-
PB13	SPI2_SCK/I2S2_CK	-	TIM1_CH1N	-	USART3_CTS	I²C2_SCL	-	EVENTOUT	-	MCO	-	TIM15_CH1N	-	I²C1_SCL	-	-
PB14	SPI2_MISO/I2S2_MCK	TIM15_CH1	TIM1_CH2N	-	USART3_RTS	I²C2_SDA	-	EVENTOUT	-	-	-	TIM15_CH1	-	I²C1_SDA	-	-
PB15	SPI2_MOSI/I2S2_SD	TIM15_CH2	TIM1_CH3N	TIM15_CH1N	-	-	-	EVENTOUT	-	-	-	-	-	-	-	-

3.3. PortC alternate function mapping

Table 3- 5 PortC alternate function mapping

PortC	AF0	AF1	AF2	AF3	AF4	AF5	AF6	AF7	AF8	AF9	AF10	AF11	AF12	AF13	AF14	AF15
PC0	EVENTOUT	-	-	-	-	-	-	-	SPI1_MISO/I2S1_MCK	USART2_CTS	USART3_RTS	-	-	-	-	-
PC1	EVENTOUT	-	-	-	-	-	-	-	SPI1_MOSI/I2S1_SD	USART2_RTS	USART3_CTS	TIM15_CH1	-	-	-	-
PC2	EVENTOUT	SPI2_MISO/I2S2_MCK	-	-	-	-	-	-	-	USART3_TX	USART3_RX	TIM15_CH2	-	-	-	-
PC3	EVENTOUT	SPI2_MOSI/I2S2_SD	-	-	-	-	-	-	-	USART3_RX	USART3_TX	-	-	-	-	-
PC4	EVENTOUT	USART3_TX	-	-	-	-	-	COMP3_OUT	SPI1_NSS/I2S1_WS	USART1_TX	-	TIM2_CH1_ETR	IR_OUT	-	-	-
PC5	-	USART3_RX	-	-	-	-	-	-	SPI1_MOSI/I2S1_SD	USART1_RX	-	TM2_CH2	-	-	-	-
PC6	TIM3_CH1	-	-	-	-	-	-	-	SPi2_SCK/I2S2_CK	-	USART4_RXD	TIM2_CH3	-	-	-	-
PC7	TIM3_CH2	-	-	-	-	-	-	-	SPI2_MISO/I2S2_MCK	-	USART4_TX	TIM2_CH4	-	-	-	-
PC8	TIM3_CH3	-	-	-	-	-	-	-	SPI2_MOSI/I2S2_SD	-	USART4_CTS	TIM1_CH1	-	-	-	-
PC9	TIM3_CH4	-	-	-	-	-	-	-	SPI2_NSS/I2S2_WS	I2S1_CKIN	USART4_RTS	TIM1_CH2	-	-	-	-
PC10	USART4_TX	USART3_TX	-	-	-	-	-	-	-	-	-	TIM1_CH3	-	-	-	-
PC11	USART4_RX	USART3_RX	-	-	-	-	-	-	-	-	-	TIM1_CH4	-	-	-	-
PC12	USART4_CK	USART3_CK	-	-	-	-	-	-	-	-	-	TIM14_CH1	-	-	-	-
PC13	-	-	-	-	-	-	-	-	SPI1_SCK/I2S1_CK	-	-	TIM1_BKIN	-	-	-	-
PC14	-	-	-	-	-	-	-	-	-	-	-	TIM1_BKIN2	-	-	-	-
PC15	-	-	-	-	-	-	-	-	-	-	-	TIM15_BKIN	-	-	-	-

3.4. PortF alternate function mapping

Table 3- 7 PortF alternate function mapping

PortC	AF0	AF1	AF2	AF3	AF4	AF5	AF6	AF7	AF8	AF9	AF10	AF11	AF12	AF13	AF14	AF15
PC0	EVENTOUT	-	-	-	-	-	-	-	SPI1_MISO/I2S1_MCK	USART2_CTS	USART3_RTS	-	-	-	-	-
PC1	EVENTOUT	-	-	-	-	-	-	-	SPI1_MOSI/I2S1_SD	USART2_RTS	USART3_CTS	TIM15_CH1	-	-	-	-
PC2	EVENTOUT	SPI2_MISO/I2S2_MCK	-	-	-	-	-	-	-	USART3_TX	USART3_RX	TIM15_CH2	-	-	-	-
PC3	EVENTOUT	SPI2_MOSI/I2S2_SD	-	-	-	-	-	-	-	USART3_RX	USART3_TX	-	-	-	-	-
PC4	EVENTOUT	USART3_TX	-	-	-	-	-	COMP3_OUT	SPI1_NSS/I2S1_WS	USART1_TX	-	TIM2_CH1_ETR	IR_OUT	-	-	-
PC5	-	USART3_RX	-	-	-	-	-	-	SPI1_MOSI/I2S1_SD	USART1_RX	-	TM2_CH2	-	-	-	-
PC6	TIM3_CH1	-	-	-	-	-	-	-	SPi2_SCK/I2S2_CK	-	USART4_RXD	TIM2_CH3	-	-	-	-
PC7	TIM3_CH2	-	-	-	-	-	-	-	SPI2_MISO/I2S2_MCK	-	USART4_TX	TIM2_CH4	-	-	-	-
PC8	TIM3_CH3	-	-	-	-	-	-	-	SPI2_MOSI/I2S2_SD	-	USART4_CTS	TIM1_CH1	-	-	-	-
PC9	TIM3_CH4	-	-	-	-	-	-	-	SPI2_NSS/I2S2_WS	I2S1_CKIN	USART4_RTS	TIM1_CH2	-	-	-	-
PC10	USART4_TX	USART3_TX	-	-	-	-	-	-	-	-	-	TIM1_CH3	-	-	-	-
PC11	USART4_RX	USART3_RX	-	-	-	-	-	-	-	-	-	TIM1_CH4	-	-	-	-
PC12	USART4_CK	USART3_CK	-	-	-	-	-	-	-	-	-	TIM14_CH1	-	-	-	-
PC13	-	-	-	-	-	-	-	-	SPI1_SCK/I2S1_CK	-	-	TIM1_BKIN	-	-	-	-
PC14	-	-	-	-	-	-	-	-	-	-	-	TIM1_BKIN2	-	-	-	-
PC15	-	-	-	-	-	-	-	-	-	-	-	TIM15_BKIN	-	-	-	-

4. Memory Map
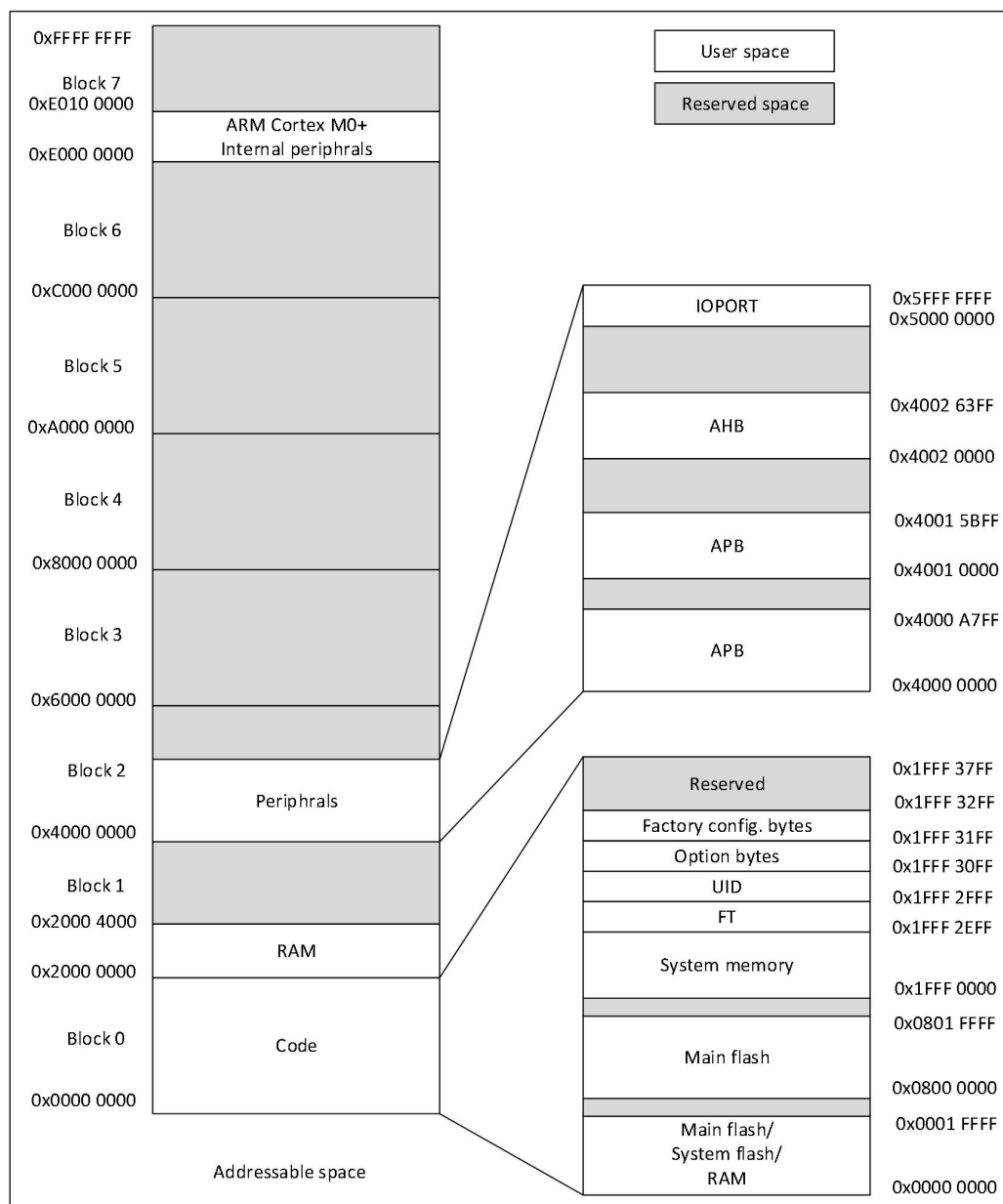
Figure 4- 1 Memory map

Table 4- 1 Memory boundary address

Type	Boundary Address	Size	Memory Area	Description
SRAM	0x2000 4000- 0x3FFF FFFF	-	Reserved	
	0x2000 0000- 0x2000 3FFF	16 KBytes	SRAM	If the hardware power-up configuration of the SRAM is 16 KBytes, then the SRAM address space is

Type	Boundary Address	Size	Memory Area	Description
				0x2000 0000-0x2000 3FFF
Code	0x1FFF 3400-0x1FFF FFFF	-	Reserved	-
	0x1FFF 3300-0x1FFF 33FF	256 Bytes	FT infor1 bytes	Flash Verify Value, Analog 和 Flash Trimming, Debug ID.
	0x1FFF 3200-0x1FFF 32FF	256 Bytes	FT infor0 bytes	Normal TS DATA, High TS DATA, HSI Re-Trim data, Flash/sram size configuration.
	0x1FFF 3100-0x1FFF 31FF	256 Bytes	Option bytes	option bytes information, IP enable[1]
	0x1FFF 3000-0x1FFF 30FF	256 Bytes	UID bytes	Unique ID
	0x1FFF 0000-0x1FFF 2FFF	12 KBytes	System memory	boot loader
	0x0802 0000-0x1FFE FFFF	-	Reserved	-
	0x0800 0000-0x0801 FFFF	128 KBytes	Main flash memory	-
	0x0002 0000-0x07FF FFFF	-	Reserved	
	0x0000 0000-0x0001 FFFF	128 KBytes	Selected based on Boot configuration, 1) Main flash memory 2) System memory 3) SRAM	

1. Except the above address, other is marked as reserved , which cannot be written , read as 0 , and a response error is generated .

Table 4- 2 Peripheral register boundary address

Bus	Boundary Address	Size	PY32F072	Access Response
	0xE000 000-0xE00F FFFF	1Mbytes	M0+	-
IOPORT	0x5000 1800 -0x5FFF FFFF	256 MB	Reserved	-
	0x5000 1400 -0x5000 17FF	1 KB	GPIOF	1.定义空间按照寄存器定义属性访问； 2.未使用空间无法写,读回 0;
	0x5000 1000 -0x5000 13FF	1 KB	Reserved	-
	0x5000 0C00 -0x5000 0FFF	1 KB	Reserved	-
	0x5000 0800 -0x5000 0BFF	1 KB	GPIOC	1.定义空间按照寄存器定义属性访问； 2.未使用空间无法写,读回 0;
	0x5000 0400 -0x5000 07FF	1 KB	GPIOB	1.定义空间按照寄存器定义属性访问； 2.未使用空间无法写,读回 0;
	0x5000 0000 -0x5000 03FF	1 KB	GPIOA	1.定义空间按照寄存器定义属性访问； 2.未使用空间无法写,读回 0;
AHB	0x4002 4000 -0x4FFF FFFF	256 MB	Reserved	-
	0x4002 3C00 – 0x4002 3FFF	1 KB	Reserved	-
	0x4002 3800 – 0x4002 3BFF	1 KB	DIV	1.定义空间按照寄存器定义属性访问； 2.未使用空间无法写,读回 0;
	0x4002 3400 -0x4002 37FF	1 KB	Reserved	-
	0x4002 3000 -0x4002 33FF	1 KB	CRC	1.定义空间按照寄存器定义属性访问； 2.未使用空间无法写,读回 0;
	0x4002 2400 -	3 KB	Reserved	-

Bus	Boundary Address	Size	PY32F072	Access Response
	0x4002 2FFF			
	0x4002 2000 - 0x4002 23FF	1 KB	FLASH	1.定义空间按照寄存器定义属性访问； 2.未使用空间无法写,读回 0;
	0x4002 1C00 - 0x4002 1FFF	1 KB	Reserved	-
	0x4002 1800 - 0x4002 1BFF	1 KB	EXTI	1.定义空间按照寄存器定义属性访问； 2.未使用空间无法写,读回 0;
	0x4002 1400 - 0x4002 17FF	1 KB	Reserved	-
	0x4002 1000 - 0x4002 13FF	1 KB	RCC[2]	1.定义空间按照寄存器定义属性访问； 2.未使用空间无法写,读回 0;
	0x4002 0400 - 0x4002 0FFF	3 KB	Reserved	-
	0x4002 0000 - 0x4002 03FF	1 KB	DMA	1.定义空间按照寄存器定义属性访问； 2.未使用空间无法写,读回 0;
APB	0x4001 5C00 - 0x4001 FFFF	41 KB	Reserved	-
	0x4001 5800 - 0x4001 5BFF	1 KB	DBG	1.定义空间按照寄存器定义属性访问； 2.未使用空间无法写,读回 0;
	0x4001 4C00 - 0x4001 57FF	3 KB	Reserved	-
	0x4001 4800 - 0x4001 4BFF	1 KB	TIM17	1.定义空间按照寄存器定义属性访问； 2.未使用空间无法写,读回 0;
	0x4001 4400 - 0x4001 47FF	1 KB	TIM16	1.定义空间按照寄存器定义属性访问； 2.未使用空间无法写,读回 0;
	0x4001 4000 - 0x4001 43FF	1 KB	TIM15	1.定义空间按照寄存器定义属性访问； 2.未使用空间无法写,读回 0;
	0x4001 3C00 - 0x4001 3FFF	1 KB	Reserved	-

Bus	Boundary Address	Size	PY32F072	Access Response
	0x4001 3800 - 0x4001 3BFF	1 KB	USART1	1.定义空间按照寄存器定义属性访问; 2.未使用空间无法写,读回 0;
	0x4001 3400 - 0x4001 37FF	1 KB	Reserved	-
	0x4001 3000 - 0x4001 33FF	1 KB	SPI1/I2S1	1.定义空间按照寄存器定义属性访问; 2.未使用空间无法写,读回 0;
	0x4001 2C00 - 0x4001 2FFF	1 KB	TIM1	1.定义空间按照寄存器定义属性访问; 2.未使用空间无法写,读回 0;
	0x4001 2800 - 0x4001 2BFF	1 KB	Reserved	-
	0x4001 2400 - 0x4001 27FF	1 KB	ADC	1.定义空间按照寄存器定义属性访问; 2.未使用空间无法写,读回 0;
	0x4001 0400 - 0x4001 23FF	8 KB	Reserved	-
	0x4001 0300 - 0x4001 03FF		OPA	1.定义空间按照寄存器定义属性访问; 2.未使用空间无法写,读回 0;
	0x4001 0200 - 0x4001 02FF	1 KB	COMP	1.定义空间按照寄存器定义属性访问; 2.未使用空间无法写,读回 0;
	0x4001 0000 - 0x4001 01FF		SYSCFG	1.定义空间按照寄存器定义属性访问; 2.未使用空间无法写,读回 0;
	0x4000 8000- 0x4000 FFFF	32 KB	Reserved	-
	0x4000 7C00 - 0x4000 7FFF	1 KB	LPTIM1	1.定义空间按照寄存器定义属性访问; 2.未使用空间无法写,读回 0;
	0x4000 7800 - 0x4000 7BFF	1 KB	Reserved	-
	0x4000 7400 - 0x4000 77FF	1 KB	DAC	1.定义空间按照寄存器定义属性访问; 2.未使用空间无法写,读回 0;

Bus	Boundary Address	Size	PY32F072	Access Response
	0x4000 7000 - 0x4000 73FF	1 KB	PWR 注3	1.定义空间按照寄存器定义属性访问; 2.未使用空间无法写,读回 0;
	0x4000 6C00 - 0x4000 6FFF	1 KB	CTC	1.定义空间按照寄存器定义属性访问; 2.未使用空间无法写,读回 0;
	0x4000 6800 - 0x4000 6BFF	1 KB	Reserved	-
	0x4000 6400 - 0x4000 67FF	1 KB	CAN	1.定义空间按照寄存器定义属性访问; 2.未使用空间无法写,读回 0;
	0x4000 6000 - 0x4000 63FF	1 KB	USB SRAM(实际以 IP 为准)	1.定义空间按照寄存器定义属性访问; 2.未使用空间无法写,读回 0;
	0x4000 5C00 - 0x4000 5FFF	1 KB	USB	1.定义空间按照寄存器定义属性访问; 2.未使用空间无法写,读回 0;
	0x4000 5800 - 0x4000 5BFF	1 KB	I^{2}C2	1.定义空间按照寄存器定义属性访问; 2.未使用空间无法写,读回 0;
	0x4000 5400 - 0x4000 57FF	1 KB	I^{2}C1	1.定义空间按照寄存器定义属性访问; 2.未使用空间无法写,读回 0;
	0x4000 5000 - 0x4000 53FF	1 KB	Reserved	-
	0x4000 4C00 - 0x4000 4FFF	1 KB	USART4	1.定义空间按照寄存器定义属性访问; 2.未使用空间无法写,读回 0;
	0x4000 4800 - 0x4000 4BFF	1 KB	USART3	1.定义空间按照寄存器定义属性访问; 2.未使用空间无法写,读回 0;
	0x4000 4400 - 0x4000 47FF	1 KB	USART2	1.定义空间按照寄存器定义属性访问; 2.未使用空间无法写,读回 0;
	0x4000 3C00 - 0x4000 43FF	2 KB	Reserved	-
	0x4000 3800 -	1 KB	SPI2/I2S2	1.定义空间按照寄存器定义属性访问;

Bus	Boundary Address	Size	PY32F072	Access Response
	0x4000 3BFF			2.未使用空间无法写,读回 0;
	0x4000 3400 - 0x4000 37FF	1 KB	Reserved	-
	0x4000 3000 - 0x4000 33FF	1 KB	IWDG	1.定义空间按照寄存器定义属性访问; 2.未使用空间无法写,读回 0;
	0x4000 2C00 - 0x4000 2FFF	1 KB	WWDG	1.定义空间按照寄存器定义属性访问; 2.未使用空间无法写,读回 0;
	0x4000 2800 - 0x4000 2BFF	1 KB	RTC	1.定义空间按照寄存器定义属性访问; 2.未使用空间无法写,读回 0;
	0x4000 2400 - 0x4000 27FF	1 KB	LCD	1.定义空间按照寄存器定义属性访问; 2.未使用空间无法写,读回 0;
	0x4000 2000 - 0x4000 23FF	1 KB	TIM14	1.定义空间按照寄存器定义属性访问; 2.未使用空间无法写,读回 0;
	0x4000 1800 - 0x4000 1FFF	2 KB	Reserved	-
	0x4000 1400 - 0x4000 17FF	1 KB	TIM7	1.定义空间按照寄存器定义属性访问; 2.未使用空间无法写,读回 0;
	0x4000 1000 - 0x4000 13FF	1 KB	TIM6	1.定义空间按照寄存器定义属性访问; 2.未使用空间无法写,读回 0;
	0x4000 0800 - 0x4000 0FFF	2 KB	Reserved	-
	0x4000 0400 - 0x4000 07FF	1 KB	TIM3	1.定义空间按照寄存器定义属性访问; 2.未使用空间无法写,读回 0;
	0x4000 0000 - 0x4000 03FF	1 KB	TIM2	1.定义空间按照寄存器定义属性访问; 2.未使用空间无法写,读回 0;

1. In the above table, the reserved address cannot be written, read back is 0, and a hardfault is generated

2. Not only supports 32 bits word access, but also supports halfword and byte access.

3. Not only supports 32 bits word access, but also supports halfword access.

5. Electrical Characteristics

5.1. Parameter conditions

Unless otherwise specified, all voltages are referenced to V_{SS}.

5.1.1. Minium and maximum values

Unless otherwise specified, the mimimum and maximum values are guaranteed in the worest condotions of ambient temperature, supply voltage and frequencies by tests in production on 100% of the devices with an ambient temperature at T_A =25°C and T_A =$T_{A(max)}$ (given by the selected temperature range).

Data based on electrical characterization results, design simulations and/or technology charateristics are indicated in the table footnotes and are not tested in production. Based on charaterization, the minimum and maximum values refer to sample tests and represent the mean vaule plus or minus three times the standard deviation.

5.1.2. Typical values

Unless otherwise specified, typical data is based on T_A =25°C and V_{CC} = 3.3V. They are given only as design guidelines and are not tested.

Typical ADC accuracy values are determined by cgaracterization of a batch of samples from a standard diffusion lot over the full temperature range, where 95% of the devices have an error less than equal to the value indicated.

5.2. Absolute maximum ratings

Stresses above the absolute maximum ratings listed in following tables may cause permanent damage to the device. These are stress ratings only and functional opeartion of the device at these conditions is not implied. Exposure to maximum rating conditions for extended periods may affect device reliability.

Table 5- 1 Voltage characteristics [1]

Symbol	Ratings	Minimum value	Maximum value	Unit
V_{CC}	External mains power supply	-0.3	6.25	V
V_{IN}	Input voltage of other pins	-0.3	V_{CC}+0.3	V

1. Power supply V_{CC} and ground V_{SS} pins must always be connected to the external power supply within the allowable range.

Table 5- 2 Current characteristics

Symbol	Describe	Maximum value	Unit
I_{VCC}	Flowing into V_{CC} pin (supply current)[1]	300	mA

Symbol	Describe	Maximum value	Unit
I_{VSS}	Total current flowing out of V_{SS} pin (outflow current)[1]	300	
$I_{IO(PIN)}$	Output sink current of COM IO[2]	20	
	Source current for all IOs	-20	

1. Power supply V_{CC} and ground V_{SS} pins must always be connected to the external power supply within the allowable range.

2. These I/O types refer to the terms and symbols defined by pins.

Table 5- 3 Thermal characteristics

Symbol	Describe	Value	Unit
T_{STG}	Storage temperature range	-65 to +150	℃
T_O	Range of operating temperature	-40 to +85	℃

5.3.   Operating conditions

5.3.1.   General operating conditions

Table 5- 4 General operating conditions

Symbol	Parameter	Condition	Minimum vaule	Maximum value	Unit
f_{HCLK}	Internal AHB clock frequency	-	0	72	MHz
f_{PCLK}	Internal APB Clock frequency	-	0	72	MHz
V_{CC}	Standard operating voltage	-	1.7	5.5	V
V_{CCA}	Operating voltage of analog circuit	Must be the same as V_{CC}	1.7	5.5	V
V_{IN}	I/O input voltage	-	-0.3	V_{CC}+0.3	V
T_A	Ambient temperature	-	-40	85	℃
T_J	Junction temperature	-	-40	105	℃

5.3.2.   Operating conditions at power-up / power-down

Table 5- 5 Operating conditions at power-up / power-down

Symbol	Parameter	Condition	Minimum vaule	Maximum value	Unit
t_{VCC}	V_{CC} rise time rate	-	0	∞	us/V
	V_{CC} fall time rate	-	20	∞	

5.3.3.   Embedded reset and LVD module features

Table 5- 6 Embedded reset module features

Symbol	Parameter	Condition	Minimum vaule	Typical value	Maximum value	Unit

Symbol	Parameter	Condition	Minimum vaule	Typical value	Maximum value	Unit
V_{PVD}	Programmable voltage detector level selection	PLS[2:0]=000 (Rising edge)	1.7	1.8	1.9	V
		PLS[2:0]=000 (Falling edge)	1.6	1.7	1.8	V
		PLS[2:0]=001 (Rising edge)	1.9	2	2.1	V
		PLS[2:0]=001 (Falling edge)	1.8	1.9	2	V
		PLS[2:0]=010 (Rising edge)	2.1	2.2	2.3	V
		PLS[2:0]=010 (Falling edge)	2	2.1	2.2	V
		PLS[2:0]=011 (Rising edge)	2.3	2.4	2.5	V
		PLS[2:0]=011 (Falling edge)	2.2	2.3	2.4	V
		PLS[2:0]=100 (Rising edge)	2.5	2.6	2.7	V
		PLS[2:0]=100 (Falling edge)	2.4	2.5	2.6	V
		PLS[2:0]=101 (Rising edge)	2.7	2.8	2.9	V
		PLS[2:0]=101 (Falling edge)	2.6	2.7	2.8	V
		PLS[2:0]=110 (Rising edge)	2.9	3	3.1	V
		PLS[2:0]=110 (Falling edge)	2.8	2.9	3	V
		PLS[2:0]=111 (Rising edge)	3.1	3.2	3.3	V
		PLS[2:0]=111 (Falling edge)	3	3.1	3.2	V

Symbol	Parameter	Condition	Minimum vaule	Typical value	Maximum value	Unit
$V_{PVDhyst}$[1]	PVD hysteresis	-	-	100	-	mV
$V_{POR/PDR}$	Power-on/power-off reset threshold	Rising edge	1.5	1.6	1.7	V
		Falling edge	1.45	1.55	1.65	V
$V_{PDRhyst}$[1]	PDR hysteresis	-	-	20	-	mV
V_{BOR}	BOR Indicates the threshold voltage	BOR_LEV[2:0]=000 (Rising edge)	1.7	1.8	1.9	V
		BOR_LEV[2:0]=000 (Falling edge)	1.6	1.7	1.8	V
		BOR_LEV[2:0]=001 (Rising edge)	1.9	2	2.1	V
		BOR_LEV[2:0]=001 (Falling edge)	1.8	1.9	2	V
		BOR_LEV[2:0]=010 (Rising edge)	2.1	2.2	2.3	V
		BOR_LEV[2:0]=010 (Falling edge)	2	2.1	2.2	V
		BOR_LEV[2:0]=011 (Rising edge)	2.3	2.4	2.5	V
		BOR_LEV[2:0]=011 (Falling edge)	2.2	2.3	2.4	V
		BOR_LEV[2:0]=100 (Rising edge)	2.5	2.6	2.7	V
		BOR_LEV[2:0]=100 (Falling edge)	2.4	2.5	2.6	V
		BOR_LEV[2:0]=101 (Rising edge)	2.7	2.8	2.9	V
		BOR_LEV[2:0]=101 (Falling edge)	2.6	2.7	2.8	V
		BOR_LEV[2:0]=110 (Rising edge)	2.9	3	3.1	V
		BOR_LEV[2:0]=110 (Falling edge)	2.8	2.9	3	V

Symbol	Parameter	Condition	Minimum vaule	Typical value	Maximum value	Unit
		BOR_LEV[2:0]=111 (Rising edge)	3.1	3.2	3.3	V
		BOR_LEV[2:0]=111 (Falling edge)	3	3.1	3.2	V
V_BOR_hyst	BOR hysteresis voltage	-	-	100	-	mV

1. Guaranteed by design, not tested in production.

2. Data is based on assessment results and is not tested in production.

5.3.4. Operating current characteristics

Table 5- 7 Operating mode current

Symbol	Condition						Typical value[1]	Maximum value	Unit
	System clock	Frequency	Code	Run	Peripheral clock	FLASH sleep			
I_{DD}(run)	HSI	72 MHz	While(1)	Flash	ON	DISABLE	8.37	-	mA
					OFF	DISABLE	4.60	-	
		48 MHz			ON	DISABLE	6.54	-	
					OFF	DISABLE	4.01	-	
		24 MHz			ON	DISABLE	3.82	-	
					OFF	DISABLE	2.60	-	
		16 MHz			ON	DISABLE	2.78	-	
					OFF	DISABLE	1.90	-	
		8 MHz			ON	DISABLE	1.80	-	
					OFF	DISABLE	1.21	-	
		4 MHz			ON	DISABLE	1.04	-	
					OFF	DISABLE	0.87	-	
	LSI	32.768 kHz			ON	DISABLE	350.2	-	uA
					OFF	DISABLE	293.2	-	
	LSI	32.768 kHz			ON	ENABLE	276.7	-	uA
					OFF	ENABLE	224.6	-	

1. Data is based on assessment results and is not tested in production.

Table 5- 8 Sleep mode current

Symbol	Condition				Typical value[1]	Maximum value	Unit
	System clock	Frequency	Peripheral clock	FLASH sleep			
I_{DD} (sleep)	HSI	72MHz	ON	DISABLE	6.16	-	mA
			OFF	DISABLE	2.13	-	mA
		48MHz	ON	DISABLE	4.57	-	
			OFF	DISABLE	1.82	-	
		24MHz	ON	DISABLE	2.12	-	mA
			OFF	DISABLE	0.89	-	mA

Symbol	Condition				Typical value[1]	Maximum value	Unit
	System clock	Frequency	Peripheral clock	FLASH sleep			
		16MHz	ON	DISABLE	1.56	-	mA
			OFF	DISABLE	0.71	-	mA
		8MHz	ON	DISABLE	1.01	-	mA
			OFF	DISABLE	0.53	-	mA
		4MHz	ON	DISABLE	0.74	-	mA
			OFF	DISABLE	0.46	-	mA
	LSI	32.768kHz	ON	DISABLE	349.4	-	uA
			OFF	DISABLE	292.5	-	uA
	LSI	32.768kHz	ON	ENABLE	278.4	-	uA
			OFF	ENABLE	224.4	-	uA

1. Data is based on assessment results and is not tested in production.

Table 5- 9 Stop mode current

Symbol	Condition					Typical value[1]	Maximum value	unit
	V_{CC}	V_{DD}	MR/LPR	LSI	Peripheral clock			
I_{DD} (stop)	1.7 to 5.5V	1.2V	MR	-	-	130.30	-	uA
		1.2V	LPR	ON	RTC+IWDG+LPTIM	6.60	-	
					IWDG	6.70	-	
					LPTIM	6.70	-	
					RTC	6.60	-	
				OFF	No	6.50	-	
		1.0V		ON	RTC+IWDG+LPTIM	5.80	-	
					IWDG	5.80	-	
					LPTIM	5.70	-	
					RTC	5.70	-	
				OFF	No	5.50	-	

1. Data is based on assessment results and is not tested in production.

5.3.5. Wake-up time for low power mode

Table 5- 10 Low power mode wake-up time

Symbol	Parameters[1]		Condition		Typical value[2]	Maximum value	Unit
$T_{WUSLEEP}$	Wake-up from sleep mode		-		7	-	CPU Cycles
T_{WUSTOP}	Wake-up from stop mode	Powered by MR	Execute program in Flash, HSI (24 MHz) as system clock		3.5	-	us
		Powered by LPR	Execute program in Flash, HSI as system clock	VDD=1.2V	7	-	us
				VDD=1.0V	7	-	

1. The wake-up time is measured from the wake-up time until the first instruction is read by the user program.

2. Data is based on assessment results and is not tested in production.

5.3.6. External clock source characteristics

5.3.6.1. External high-speed clock

In bypass mode of HSE (the HSEBYP of RCC_CR is set), when the high-speed start-up circuit in the chip stops working, the corresponding I/O is used as a standard GPIO.

Figure 5- 1 External high-speed clock timing diagram

Table 5- 11 External high-speed clock features

Symbol	Parameters[1]	Minimum value	Typical value	Maximum value	Unit
f_{HSE_ext}	User external clock source frequency	0	8	32	MHz
V_{HSEH}	Input pin high level voltage	$0.7V_{CC}$	-	V_{CC}	V
V_{HSEL}	Input pin low level voltage	V_{SS}	-	$0.3V_{CC}$	
$t_{W(HSEH)}$ $t_{W(HSEL)}$	Enter high or low time	15	-	-	ns
$t_{r(HSE)}$ $t_{f(HSE)}$	Enter the rise/fall time	-	-	20	ns

1. Guaranteed by design, not tested in production.

5.3.6.2. External low-speed clock

In the bypass mode of LSE (the LSE BYP of RCC_BDCR is set), the low-speed start-up circuit in the chip stops working, and the corresponding I/O is used as a standard GPIO.
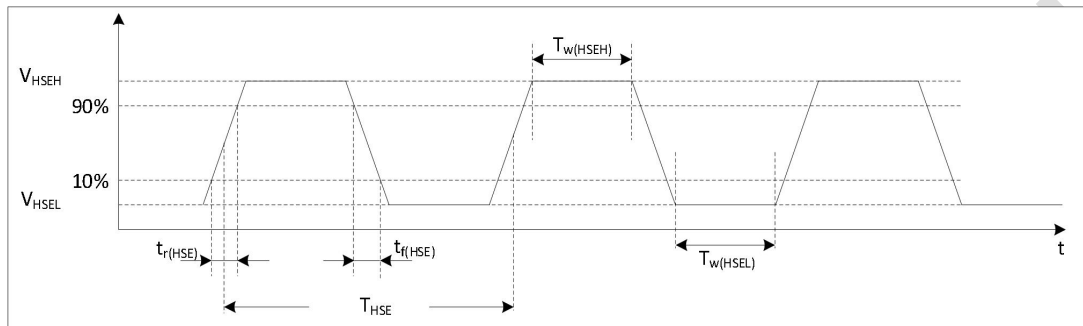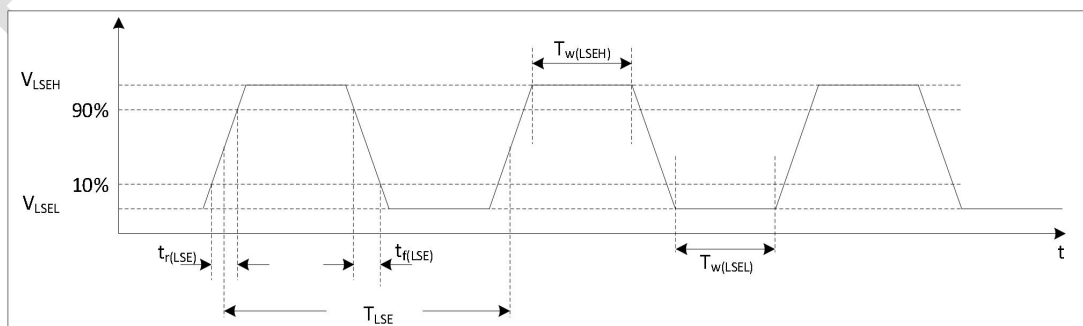

Figure 5- 2 External low-speed clock timing diagram

Table 5- 12 External low-speed clock characteristics

Symbol	Parameters[1]	Minimum value	Typical value	Maximum value	Unit
f_{LSE_ext}	User external clock frequency	-	32.768	1000	KHz
V_{LSEH}	Input pin high level voltage	$0.7V_{CC}$	-	-	V
V_{LSEL}	Input pin low level voltage	-	-	$0.3V_{CC}$	V
$t_{W(LSEH)}$ $t_{W(LSEL)}$	Enter high or low time	450	-	-	ns
$t_{r(LSE)}$ $t_{f(LSE)}$	Enter the rise/fall time	-	-	50	ns

1. Guaranteed by design, not tested in production .

5.3.6.3. External high-speed crystal

The high-speed external (HSE) clock can be supplied with a ~32 MHz crystal/ceramic resonator oscillator. In the application, the resonator and the load capacitors have to be placed as close as possible to the oscillator pins in order to minimize output distortion and startup stabilization time.

Table 5- 13 External high-speed crystal characteristics

Symbol	Parameter	Condition[1]	Minimum value[2]	Typical value	Maximum value[2]	Unit
f_{OSC_IN}	Oscillation frequency	-	1	-	32	MHz
IDD[4]	HSE current consumption	During startup	-	-	5.5	mA
		V_{CC} = 3 V, Rm = 30 Ω , C_L = 10 pF@8 MHz	-	0.58	-	
		V_{CC} = 3 V, Rm = 45 Ω , C_L = 10 pF@8 MHz	-	0.59	-	
		V_{CC} = 3 V, Rm = 30 Ω , C_L = 5 pF@48 MHz	-	0.89	-	
		V_{CC} = 3 V, Rm = 30 Ω , CL = 10 pF@48 MHz	-	1.14	-	
		V_{CC} = 3 V, Rm = 30 Ω , C_L = 20 pF@48 MHz	-	1.94	-	
$t_{SU(HSE)}$[3][4]	Startup Time	f_{OSC_IN} = 32 MHz	-	2	-	ms
		f_{OSC_IN} = 4 MHz	-	2	-	ms

1. Crystal/ceramic resonator characteristics are based on the manufacturer's datasheet.

2. Guaranteed by design, not tested in production.

3. $t_{SU(HSE)}$ is the startup time from enable (by software) to when the clock oscillation reaches a stable state , measured for a standard crystal/resonator, which can vary considerably from one crystal/resonator to another .

4. Data is based on assessment results and is not tested in production.

5.3.6.4. External low speed crystal

The low-speed external (LSE) clock can be supplied with a 32.768 KHz crystal resonator oscillator. In the application, the resonator and the load capacitors have to be placed as close as possible to the oscillator pins in order to minimize output distortion and startup stabilization time.

Table 5- 14 External low-speed crystal feature

Symbol	Parameter	Condition[1]	Minimum value[2]	Typical value	Maximum value[2]	Unit
IDD[4]	LSE current consumption	LSE_DRIVER [1:0] = 00	-	250	-	nA
		LSE_DRIVER [1:0] = 01	-	560	-	
		LSE_DRIVER [1:0] = 10	-	920	-	
		LSE_DRIVER[1:0] = 11	-	1260	-	
$t_{SU(LSE)}$[3][4]	Startup Time	-	-	3	-	s

1. Crystal/ceramic resonator characteristics are based on the manufacturer's datasheet.

2. Guaranteed by design, not tested in production.

3. $t_{SU(LSE)}$ is the startup time from enable (by software) to when the clock oscillation reaches a stable , measured for a standard crystal/resonator , which may vary greatly from crystal to resonator.

4. Data is based on assessment results and is not tested in production.

5.3.7. Internal high frequency clock source HSI characteristics

Table 5- 15 Internal high frequency clock source characteristics

Symbol	Parameter	Condition	Minimum value	Typical value	Maximum value	Unit
f_{HSI}	HSI frequency	-	-	4.0 8.0 16.0 22.12 24.0	-	MHz
$\Delta Temp_{(HSI)}$	HSI frequency temperature drift	V_{CC} = 1.7 to 5.5 V, T_A = 25 C	-1[2]	-	1[2]	%
		V_{CC} = 1.7 to 5.5 V, T_A = 0 to 85 C	-2[2]	-	2[2]	%
		V_{CC} = 1.7 to 5.5 V, T_A = -40 to 85 C	-4[2]	-	2[2]	%
$fTRIM_{(1)}$	HSI fine-tuning accuracy	-	-	0.1	-	%
$\Delta T_{emp(HSI)}$	HSI frequency temperature drift	-	45[1]	-	55[1]	%
$tStab_{(HSI)}$	HSI stabilization time	-	-	2	4[1]	us
f_{TRIM}[1]	HSI fine-tuning accuracy	4 MHz	-	110	-	uA
		8 MHz	-	120	-	uA

Symbol	Parameter	Condition	Minimum value	Typical value	Maximum value	Unit
		16 MHz	-	170	-	uA
		22.12 MHz, 24 MHz	-	210	-	uA

1. Guaranteed by design, not tested in production.

2. Data is based on assessment results and is not tested in production.

5.3.8. Internal low frequency clock source LSI characteristics

Table 5- 17 Internal low frequency clock characteristics

Symbol	Parameter	Condition	Minimum vaule	Typical value	Maximum value	Unit
f_{LSI}	LSI frequency	-	-	32.768 kHz	-	KHZ
$\Delta T_{emp(LSI)}$	LSI frequency temperature drift	V_{CC} = 3.3 V, T_A = 25 °C	-3	-	+3	%
		V_{CC} = 1.6 to 5.5 V, T_A = 0 to 85 °C	-10[2]	-	10[2]	%
		V_{CC} = 1.6 to 5.5 V, T_A = -40 to 85 °C	-20[2]	-	20[2]	%
f_{TRIM}[1]	LSI fine-tuning accuracy	-	-	0.2	-	%
$t_{Stab(LSI)}$[1]	LSI stabilization time	-	-	150	-	us
$I_{DD(LSI)}$[1]	LSI current consumption	-	-	210	-	nA

1. Guaranteed by design, not tested in production.

2. Data is based on assessment results and is not tested in production.

5.3.9. Phase locked loop (PLL) characteristics

Table 5- 16 Phase locked loop characteristics

Symbol	Parameter	Condition	Minimum value	Typical value	Maximum value	Unit
f_{PLL_IN}	input frequency	T_A = 25 °C, V_{CC} = 3.3 V PLL 2 倍频	12[1]	-	24[1]	MHz
		T_A = 25 °C, V_{CC} = 3.3 V PLL 3 倍频	16[1]	-	24[1]	MHz
f_{PLL_OUT}	Output frequency	T_A = 25 °C, V_{CC} = 3.3 V	24[1]	-	72	MHz
Jitter	Period jitter	-	-	-	0.3[1]	ns
t_{LOCK}	Latch time	f_{PLL_IN} = 24 MHz	-	15	40[1]	us

1. Guaranteed by design, not tested in production.

5.3.10. Memory characteristics

Table 5- 17 Memory characteristics

Symbol	Parameter	Condition	Typical value	Maximum value[1]	Unit
t_{prog}	Page program	-	1.0	1.5	ms
t_{ERASE}	Page/sector/mass erase	-	3.0	4.5	ms
I_{DD}	Page programe		2.1	2.9	mA
	Page/sector/mass erase		2.1	2.9	mA

1. Guaranteed by design, not tested in production.

Table 5- 18 Memory erase times and data retention

Symbol	Parameter	Condition	Minimum[1]	Unit
N_{END}	Erase and write times	T_A = -40 to 85 ℃	100	kcycle
t_{RET}	Data retention period	10 Kcycle T_A = 55 ℃	20	Year

1. Data is based on assessment results and is not tested in production.

5.3.11. EFT characteristics

Symbol	Parameter	Condition	Grade	Typical value	Unit
EFT to IO	-	IEC61000-4-4	B	2	kV
EFT to Power	-	IEC61000-4-4	B	4	kV

5.3.12. ESD & LU characteristics

Table 5- 19ESD & LU characteristics

Symbol	Parameter	Condition	Typical value	Unit
$V_{ESD(HBM)}$	Static discharge voltage (human body model)	ESDA/JEDEC JS-001-2017	8	KV
$V_{ESD(CDM)}$	Static discharge voltage (charging equipment model)	ESDA/JEDEC JS-002-2018	1	KV
$V_{ESD(MM)}$	Static discharge voltage (machine model)	JESD22-A115C	200	V
LU	Static latch-up	JESD78E	200	mA

5.3.13. Port characteristics

Table 5- 20 IO static characteristics

Symbol	Parameter	Condition	Minimum value	Typical value	Maximum value	Unit
V_{IH}	Input high level voltage	V_{CC} = 1.7 to 5.5 V	$0.7V_{CC}$	-	-	V
V_{IL}	Input low level voltage	V_{CC} = 1.7 to 5.5 V	-	-	$0.3V_{CC}$	V
V_{hys}[1]	Schmitt hysteresis voltage	-	-	200		mV

Symbol	Parameter	Condition	Minimum value	Typical value	Maximum value	Unit
I_{lkg}	Input leakage current	-	-	-	1	uA
R_{PU}	Pull-up resistor	-	30	50	70	k Ω
R_{PD}	Pull-down resistor	-	30	50	70	k Ω
C_{IO}[1]	Pin capacitance	-	-	5	-	pF

1. Guaranteed by design, not tested in production.

Table 5- 21 Output voltage characteristics

Symbol	Parameters[1]	Condition	Minimum	Maximum	Unit
V_{OL}	COM IO output low level	I_{OL} = 8 mA, $V_{CC} \geq$ 2.7 V	-	0.4	V
V_{OL}		I_{OL} = 4 mA, V_{CC} = 1.8 V	-	0.5	V
V_{OL}[3]	Output low level voltage for an I/O pin	I_{OL} = 8 mA, $V_{CC} \geq$ 2.7 V	-	0.4	V
V_{OL}[3]		I_{OL} = 4 mA, V_{CC} = 1.8 V	-	0.4	V
V_{OH}	COM IO output high level	I_{OH} = 8 mA, $V_{CC} \geq$ 2.7 V	V_{CC}–0.4	-	V
V_{OH}		I_{OH} = 4 mA, V_{CC} = 1.8 V	V_{CC}–0.5	-	V
V_{OH}[3]	Output high level voltage for an I/O pin	I_{OL} = 8 mA, $V_{CC} \geq$ 2.7 V	V_{CC}–0.4		V
V_{OH}[3]		I_{OL} = 4 mA, V_{CC} = 1.8 V	V_{CC}–0.4		V

1. IO types can refer to the terms and symbols defined by the pins.

2. Data is based on assessment results and is not tested in production.

5.3.14. NRST pin characteristics

Table 5- 22NRST pin characteristics

Symbol	Parameter	Condition	Minimum value	Typical value	Maximum value	Unit
V_{IH}	Input high level voltage	V_{CC} = 1.7 to 5.5 V	$0.7V_{CC}$	-	-	V
VIL	Input low level voltage	V_{CC} = 1.7 to 5.5 V	-	-	$0.2V_{CC}$	V
V_{hys}[1]	Schmitt hysteresis voltage	-	-	300	-	mV
I_{lkg}	Input leakage current	-	-	-	1	uA
RPU[1]	Pull-up resistor	-	30	50	70	k Ω
RPD[1]	Pull-down resistor	-	30	50	70	k Ω
C_{IO}_	Pin capacitance	-	-	5	-	pF

1. Guaranteed by design, not tested in production.

5.3.15. ADC characteristics

Table 5- 23ADC characteristics

Symbol	Parameter	Condition	Minimum value	Typical value	Maximum value	Unit
I_{CC}	Current consumption	@0.75MSPS	-	0.4	-	mA
C_{IN}[1]	Internal sample and hold capacitors	-	-	5	8	pF

Symbol	Parameter	Condition	Minimum value	Typical value	Maximum value	Unit
F_{ADC}	Convert clock frequency	V_{CC} = 1.7 to 2.3 V	1	4	8[2]	MHz
		V_{CC} = 2.3 to 5.5 V	1	8	16[2]	MHz
T_{samp}[1]		V_{CC} = 1.7 to 2.3 V	3.5* Tclk		41.5* Tclk	
T_{conv}[1]				12*Tclk		
T_{eoc}[1]				0.5*Tclk		
DNL[2]	RT			±1	-1~1.5	LSB
INL[2]	RT				±3	LSB
Offset[2]	RT			±1.5	±3	LSB

1. Guaranteed by design, not tested in production.

2. Data is based on assessment results and is not tested in production.

5.3.16. DAC features

Symbol	Parameter	Minimum value	Typical value	Maximum value	Unit	Comments
V_{DDA}	Analog supply voltage	2.2	-	5.5	V	-
R_{LOAD}[1]	Resistive load vs. V_{SSA} with buffer ON	5	-	-	kΩ	
	Resistive load vs. V_{CCA} with buffer ON	15	-	-	kΩ	
R_O[1]	Impedance output with buffer OFF	-	-	15	kΩ	The minimum resistive load between DAC_VOUT and V_{SS} to have a 1% accuracy is 1.5 MΩ .
C_{LOAD}[1]	Capacitive load	-	-	50	pF	Maximum capacitive load at DAC_OUT pin (when the buffer is ON).
DAC_OUT	Lower DAC_OUT voltage with	0.2	-	-	V	It gives the maximum output

Symbol	Parameter	Minimum value	Typical value	Maximum value	Unit	Comments
min[1]	buffer ON					excursion of the DAC.
DAC_OUT max[1]	Higher DAC_OUT voltage with buffer ON	-	-	V_{DDA} - 0.2	V	
DAC_OUT min[1]	Lower DAC_OUT voltage with buffer OFF	-	0.5	-	mV	It gives the maximum output excursion of the DAC.
DAC_OUT max[1]	Higher DAC_OUT voltage with buffer OFF	-	-	$V_{DDA} - 10$ mV	V	
I_{DDA}[1]	DAC DC current consumption in quiescentmode (2)	-	-	600	µA	With no load, middle code (0x800) on the inputs
		-	-	700	µA	With no load, worst code (0xF1C) at VREF+ = 3.6 V in terms of DC consumption on the inputs
DNL[2]	Differential linearity error	-	-	±1	LSB	Given for the DAC in 10 bits configuration
		-	-	±3	LSB	Given for the DAC in 12 bits configuration
INL[2]	Integral linearity error	-	-	±1	LSB	Given for the DAC in 10 bits configuration

Symbol	Parameter	Minimum value	Typical value	Maximum value	Unit	Comments
				±4	LSB	Given for the DAC in 12 bits
						configuration
Offset[2]	offset error	-	-	±3	LSB	Given for the DAC in 10 bits
		-	-	±12	LSB	Given for the DAC in 12 bits
Gain error[2]	Gain error	-	-	±0.5	%	Given for the DAC in 12 bits
						configuration
$t_{SETTLING}$[2]	Settling time (full scale: for a 10 bits input code transition between the lowest and the highest input codes when DAC_OUT reaches finalvalue ±1LSB	-	4	10	µs	$C_{LOAD} \le 50$ pF, $R_{LOAD} \ge 5$ kΩ
Update rate[2]	Max frequency for a correct DAC_OUT change when small variation in the inputcode (from code i to i+1LSB)	-	-	1	MS/s	$C_{LOAD} \le 50$ pF, $R_{LOAD} \ge 5$ kΩ
t_{WAKEUP}[2]	Wakeup time from off state	-	6.5	10	µs	$C_{LOAD} \le 50$ pF, $R_{LOAD} \ge 5$ kΩ

Symbol	Parameter	Minimum value	Typical value	Maximum value	Unit	Comments
						input code between lowest and highest possible ones.
P_{SRR+}[1]	Power supply rejection ratio (to V_{DDA}) (static DC measurement	-	-67	-40	dB	No R_{LOAD}, C_{LOAD} = 50 pF

5.3.17. Comparator characteristics

Table 5- 24 Comparator characteristics[1]

Symbol	Parameter	Condition		Minimum value	Typical value	Maximum value	Unit
V_{IN}	Input voltage range			0		V_{CC}	V
V_{SC}	Scaler offset voltage				±5	± 10	mV
I_{DD}(SCALER)	Scaler static consumption				0.8	1	uA
t_{START_SCALER}	Scaler startup time				100	200	us
t_{START}	Startup time to reach propagation delay specification	High-speed mode				5	us
		Medium-speed mode				15	
t_D	Propagation delay	200 mV step, 100 mV overdrive	High-speed mode			40	70	ns
			Medium-speed mode			0.9	2.3	us
		>200 mV step, 100 mV overdrive	High-speed mode				85	ns
			Medium-speed mode				3.4	us
V_{offset}	Offset error				±5		mV
V_{hys}	Hysteresis	No hysteresis			0		mV
		With hysteresis			20		
I_{DD}	Consumption	Medium-speed mode, no deglitcher	Static		5		uA
			With 50 KHz and		6		uA

Symbol	Parameter	Condition		Minimum value	Typical value	Maximum value	Unit
			±100 mv overdrive square signal				
		Medium-speed mode, with deglitcher	Static		7		uA
			With 50 KHz and ±100 mv overdrive square signal		8		uA
		High-speed mode, no deglitcher	Static		250		uA
			With 50 KHz and ±100 mv overdrive square signal		250		uA

1. Guaranteed by design, not tested in production.

5.3.18. Operational amplifier characteristics

Symbol	Parameter	Condition	Minimum value	Typical value	Maximum value	Unit
V_i	Input voltage		0		AV_{CC}	V
V_o	The output voltage		0.1		AV_{CC} - 0.2	V
I_o	Output current				2.2	mA
R_L	load time		5K			Ω
T_{start}	initialization time				20	us
V_{io}	Input offset voltage			±6		mV
PM	Phase margin			80		Deg
UGBW	unity gain width			10		MHz
SR	Slew rate			8		V/us

5.3.19. Temperature sensor characteristics

Table 5- 25 Temperature sensor characteristics

Symbol	Parameter	Minimum value	Typical value	Maximum value	Unit
T_L[1]	VTS linearity with temperature		±1	±2	℃
Avg_Slope[1]	Average slope	2.3	2.5	2.7	mV/℃
V_{30}	Voltage at 30 ℃ (±5 ℃)	0.742	0.76	0.785	V
t_{START}[1]	Start up time entering in continuous mode		70	120	us

Symbol	Parameter	Minimum value	Typical value	Maximum value	Unit
t_{s_temp}[1]	ADC sampling time when reading the temperature	9			us

1. Guaranteed by design, not tested in production.

2. Data is based on assessment results and is not tested in production.

5.3.20. Built-in reference voltage characteristics

Table 5- 26 Built-in reference voltage characteristics

Symbol	Parameter	Minimum value	Typical value	Maximum value	Unit
V_{REFINT}	Internal reference voltage	1.17	1.2	1.23	V
$T_{start\_vrefint}$	Start time of internal reference voltage		10	15	us
T_{coeff}	Temperature coefficient			100[1]	ppm/°C
I_{vcc}	Current consumption from V_{CC}		12	20	uA

1. Guaranteed by design, not tested in production.

5.3.21. Built-in reference voltage

Symbol	Parameter	Condition	Minimum value	Typical value	Maximum value	Unit
V_{REF25}	Internal 2.5V reference voltage	T_A=25°C,V_{CC}=3.3V	2.475	2.5	2.525	V[1]
V_{REF25}	Start time of internal reference voltage	T_A=-40°C-85°C,V_{CC1}=1.7-5.5V	2.463	2.5	2.525	V[1]
$V_{REF2048}$	Internal 2.048V reference voltage	T_A=25°C,V_{CC}=3.3V	2.028	2.048	2.068	
	Start time of internal reference voltage	T_A=-40°C-85°C,V_{CC1}=1.7-5.5V	2.020	2.048	2.076	
V_{REF15}	Internal 2.5V reference voltage	T_A=25°C,V_{CC}=3.3V	1.485	1.5	1.515	V
V_{REF15}	Current consumption from V_{CC}	T_A=-40°C-85°C,V_{CC1}=1.7-5.5V	1.477	1.5	1.519	V[1]
T_{coeff}	Internal 2.5V/1.5V temperature coefficient	T_A=-40°C-85°C			120	ppm/°C

5.3.22. Timer characteristics

Table 5- 27 Timer characteristics

Symbol	Parameter	Condition	Minimum	Maximum	Unit
$t_{res(TIM)}$	Timer resolution time	-	1	-	$t_{TIMxCLK}$

Symbol	Parameter	Condition	Minimum	Maximum	Unit
		$f_{TIMxCLK}$ = 72 MHz	13.889	-	ns
f_{EXT}	Timer external clock frequency on CH1 to CH4	-	-	$f_{TIMxCLK}$/2	MHz
		$f_{TIMxCLK}$ = 72 MHz	-	24	
Res_{TIM}	Timer resolution	TIM1/3/14/15/16/17	-	16	Bit
$t_{COUNTER}$	16 bits counter clock period	-	1	65536	$t_{TIMxCLK}$
		$f_{TIMxCLK}$ = 72 MHz	0.013889	913	us

Table 5- 28LPTIM characteristics (clock selection LSI)

Prescaler	PRESC [2:0]	Minimum overflow value	Maximum overflow value	Unit
/1	0	0.0305	1998.848	
/2	1	0.0610	3997.696	
/4	2	0.1221	8001.9456	
/8	3	0.2441	15997.3376	
/16	4	0.4883	32001.2288	ms
/32	5	0.9766	64002.4576	
/64	6	1.9531	127998.3616	
/128	7	3.9063	256003.2768	

Table 5- 29IWDG characteristics (clock selection LSI)

Prescaler	PR[2:0]	Minimum overflow value	Maximum overflow value	Unit
/4	0	0.122	499.712	
/8	1	0.244	999.424	
/16	2	0.488	1998.848	
/32	3	0.976	3997.696	ms
/64	4	1.952	7995.392	
/128	5	3.904	15990.784	
/256	6 or 7	7.808	31981.568	

Table 5- 30 WWDG characteristics (Clock selection 4 8MHz PCLK)

Prescaler	WDGTB[1:0]	Minimum overflow value	Maximum overflow value	Unit
1*4096	0	0.085	5.461	
2*4096	1	0.171	10.923	ms
4*4096	2	0.341	21.845	
8*4096	3	0.683	43.691	

5.3.23. Communication port characteristics

5.3.23.1. I²C bus interface features

The I²C interface meets the timing requirements of the I²C-bus specification and user manual:

- Standard-mode (Sm): 100 kbit/s

- Fast-mode (Fm): 400 kbit/s

The I²C timings requirements is guaranteed by design, provided the I²C peripheral is properly configured and the I²C CLK frequency is greater than the minimum required in the table below.

Table 5-31 Minimum I²C CLK frequency

Symbol	Parameter	Condition	Minimum	Unit
$f_{I2CCLK(min)}$	Minimum I²C CLK frequency	Standard-mode	2	MHz
		Fast-mode	9	

I²C SDA and SCL pins have analogue filtering, see table below.

Table 5-32 I²C filter characteristics

Symbol	Parameter	Minimum	Maximum	Unit
t_{AF}	Lmiting duration of spikes suppressed by the filter (spikers shorter than the limiting duration are suppressed)	50	260	ns

5.3.23.2. Serial peripheral interface (SPI) characteristics

Table 5-33 SPI characteristics

Symbol	Parameter	Condition	Minimum	Maximum	Unit
f_{SCK} $1/t_{c(SCK)}$	SPI clock frequency	Master mode	-	12	MHz
		Slave mode	-	12	
$t_{r(SCK)}$ $t_{f(SCK)}$	SPI clock rise and fall time	Capacitive load: C = 15 pF	-	6	ns
$t_{su(NSS)}$	NSS setup time	Slave mode	4Tpclk	-	ns
$t_{h(NSS)}$	NSS hold time	Slave mode	2Tpclk + 10	-	ns
$t_{w(SCKH)}$ $t_{w(SCKL)}$	SCK high and low time	Master mode, f_{PCLK} = 36 MHz, presc = 4	Tpclk*2 - 2	Tpclk*2 + 1	ns
$t_{su(MI)}$ $t_{su(SI)}$	Data input setup time	Master mode, f_{PCLK} = 48 MHz, presc = 4	Tpclk + 5[1]	-	ns
		Slave mode, f_{PCLK} = 48 MHz, presc = 4	5	-	
$t_{h(MI)}$	Data input hold time	Master mode	5	-	ns
$t_{h(SI)}$		Slave mode	Tpclk + 5	-	
$t_{a(SO)}$	Data output access time	Slave mode, presc = 4	0	3Tpclk	ns
$t_{dis(SO)}$	Data output disable time	Slave mode	2Tpclk + 5	4Tpclk + 5	ns
$t_{v(SO)}$	Data output valid ime	Slave mode (after enable edge), presc = 4	0	1.5Tpclk[2]	ns
$t_{v(MO)}$	Data output valid ime	Master mode (after enable edge)	-	6	ns
$t_{h(SO)}$	Data output hold time	Slave mode, presc = 4	0[3]	-	ns
$t_{h(MO)}$		Master mode	2	-	
DuCy(SCK)	SPI slave input clock duty cycle	Slave mode	45	55	%

1. The Master generates a 1 pclk receive control signal before the receive edge.

2. Slave has a maximum of 1 pclk based on the sending edge of SCK delay, considering IO delay, etc., define 1.5 pclk.

3. Between the receiving edge and the sending edge , the slave updates the data before the sending edge.
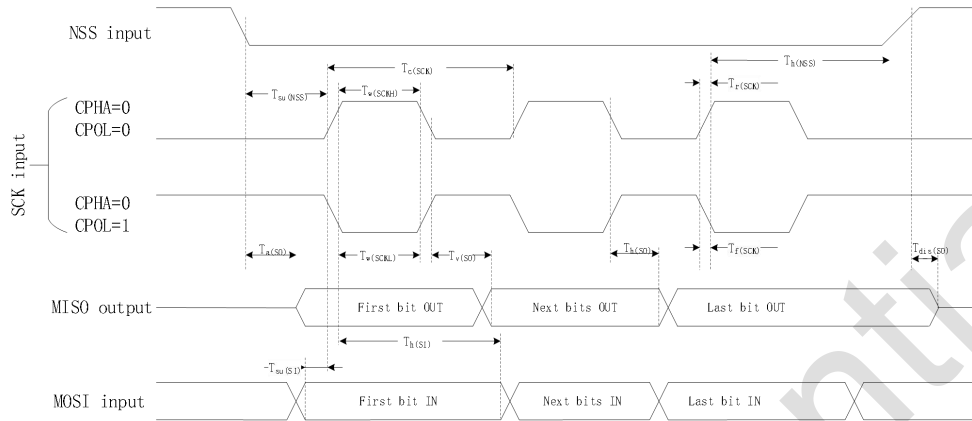
Figure 5- 3 SPI timing diagram – slave mode and CPHA=0
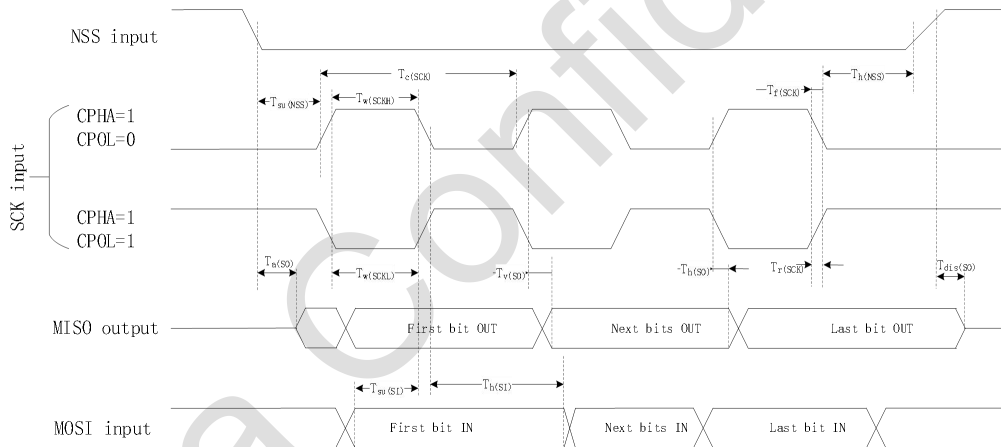
Figure 5- 4 SPI timing diagram – slave mode and CPHA=1

Figure 5‑5 SPI timing diagram – master mode

6. Package Information

6.1. LQFP64 package size

Common Dimensions
(Unit of Measure=millimeters)

Symbol	Min	Typ	Max
A	-	-	1.600
A1	0.050	-	0.150
A2	1.350	1.400	1.450
b	0.180	-	0.270
c	0.130	-	0.180
D	11.950	12.000	12.050
D1	9.900	10.000	10.100
E	11.950	12.000	12.050
E1	9.900	10.000	10.100
e		0.500BSC	
L	0.530	-	0.700
L1		1.000REF	
θ	0	-	7°

Note：1. Dimensions are not to scale
　　　　2.Have two shape can be compatible
with each other

	TITLE	DRAWING NO.	REV
PUYA	Puya LQFP64L 10x10X1.6-0.5PITCH	QRPD-0051	1.0

6.2. LQFP48 package size

Common Dimensions
(Unit of Measure=millimeters)

Symbol	Min	Typ	Max
A	-	-	1.600
A1	0.050	-	0.150
A2	1.350	1.400	1.450
b	0.180	-	0.270
c	0.130	-	0.180
D	8.800	9.000	9.200
D1	6.900	7.000	7.100
E	8.800	9.000	9.200
E1	6.900	7.000	7.100
e		0.500BSC	
L	0.450	-	0.750
L1		1.000REF	
θ	0	-	7°

Note：1. Dimensions are not to scale
    2.Have two shape can be compatible
with each other

	TITLE	DRAWING NO.	REV
PUYA	Puya LQFP48L 7x7X1.6-0.5PITCH	QRPD-0050	1.0

6.3. QFN64 package size

TOP VIEW

SIDE VIEW

Pin1

64

1

2

D

E

A

A1

c

BOTTOM VIEW

D2
Nd

L

Ne
E2

2
1

64

e

b

BOTTOM VIEW

Common Dimensions
(Unit of Measure=millimeters)

Symbol	Min	Typ	Max
A	0.700	0.750	0.800
A1	0.000	0.020	0.050
b	0.150	0.200	0.250
c		0.203REF	
D	7.900	8.000	8.100
D2	6.400	6.500	6.600
E	7.900	8.000	8.100
E2	6.400	6.500	6.600
e		0.400BSC	
Nd		6.000BSC	
Ne		6.000BSC	
L	0.350	0.400	0.450
h	0.300	0.350	0.400

Note: 1. Dimensions are not to scale

PUYA	TITLE Puya QFN64L 8X8X0.75-0.4PITCH POD	DRAWING NO. QRPD-0057	REV 1.0

6.4. QFN48 package dimensions

TOP VIEW

SIDE VIEW

Pin1

48
1
2

D

E

A

A1

c

BOTTOM VIEW

D2

E2

Ne

Nd

L

h
2

h

e

b

Common Dimensions
(Unit of Measure=millimeters)

Symbol	Min	Typ	Max
A	0.700	0.750	0.800
A1	0.000	0.020	0.050
b	0.150	0.200	0.250
c		0.200REF	
D	5.900	6.000	6.100
D2	4.100	4.300	4.500
E	5.900	6.000	6.100
E2	4.100	4.300	4.500
e		0.400BSC	
Nd		4.400BSC	
Ne		4.400BSC	
L	0.300	0.400	0.500
h	0.300	0.350	0.400

Note: 1. Dimensions are not to scale
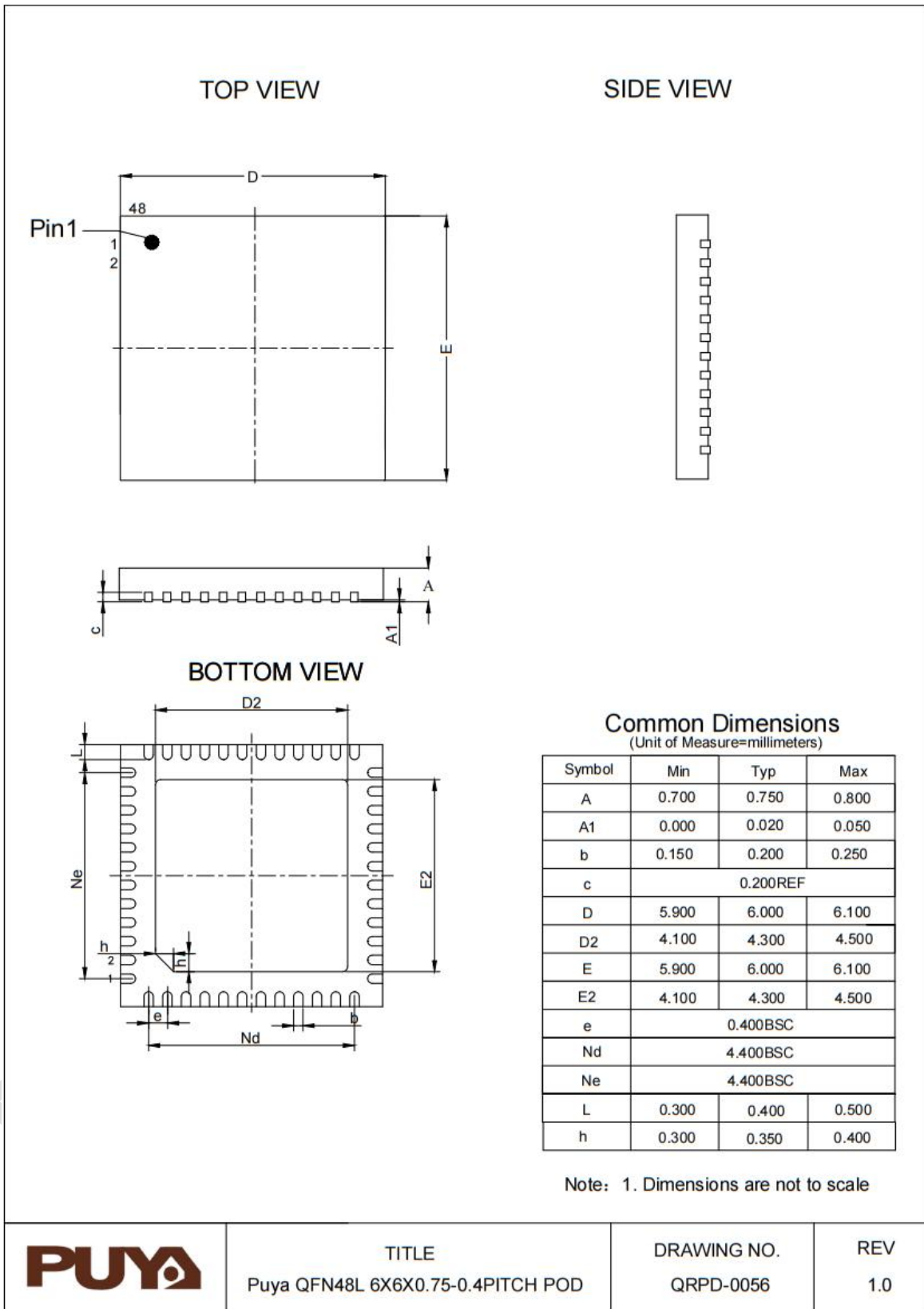
PUYa

TITLE	DRAWING NO.	REV
Puya QFN48L 6X6X0.75-0.4PITCH POD	QRPD-0056	1.0

6.5. QFN32 package dimensions

TOP VIEW

SIDE VIEW

Pin1

BOTTOM VIEW

Common Dimensions
(Unit of Measure=millimeters)

Symbol	Min	Typ	Max
A	0.700	0.750	0.800
A1	0	0.020	0.050
b	0.180	0.250	0.300
c		0.200REF	
D	4.900	5.000	5.100
D2	3.400	3.500	3.600
E	4.900	5.000	5.100
E1	3.400	3.500	3.600
e		0.500BSC	
Nd		3.500BSC	
L	0.350	0.400	0.450
h	0.300	0.350	0.400

BOTTOM VIEW

Note：1. Dimensions are not to scale
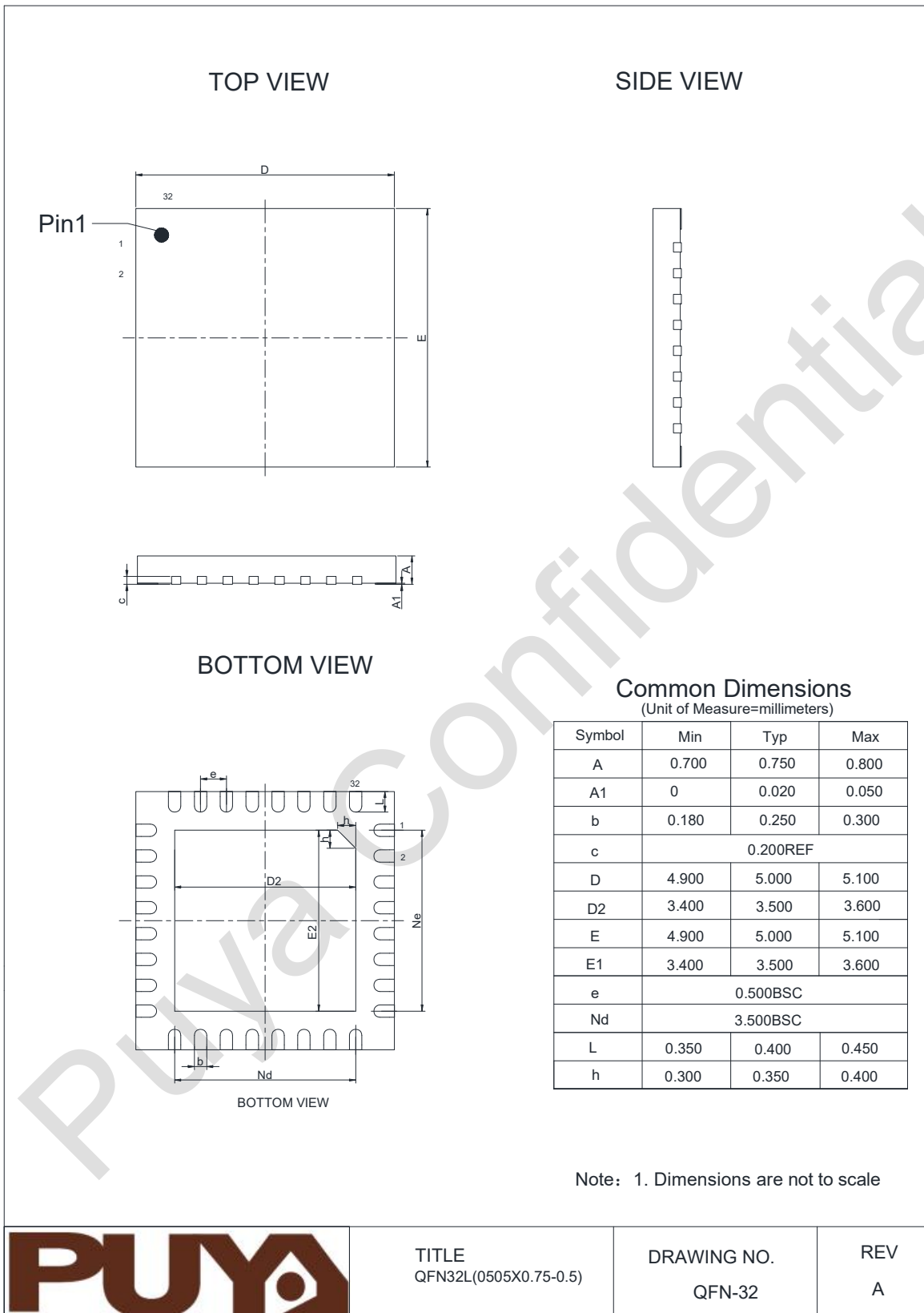
	TITLE QFN32L(0505X0.75-0.5)	DRAWING NO. QFN-32	REV A

7. Ordering Information

Example:

PY 32 F 072 R1 8 T 6 x

Company
PY = Puya Semiconductor

Product family
32bit MCU

Product type
F = General purpose

Sub-family
072 = PY32F072xx

Pin count
K1 = 32 pins Pinout1
C1 = 48 pins Pinout1
R1 = 64 pins Pinout1

User code memory size
6 = 32 Kbytes
7 = 48 Kbytes
8 = 64 Kbytes
9 = 96 Kbytes
B = 128 Kbytes

Package
U = QFN
T = LQFP

Temerature range
6 = -40℃ to +85℃

Options
xxx = code ID of programmed parts(includes packing type)
TR = tape and reel packing
TU = Tube Packing
blank = tray packing

8. Version History

Version	Date	Updated record
V1.0	2023.08.31	Initial version

PUYA

Puya Semiconductor Co., Ltd.

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